

Task 2: Modeling and Simulation of Conducted and Radiated EMI from HPM and UWB Sources on PCBs and ICs

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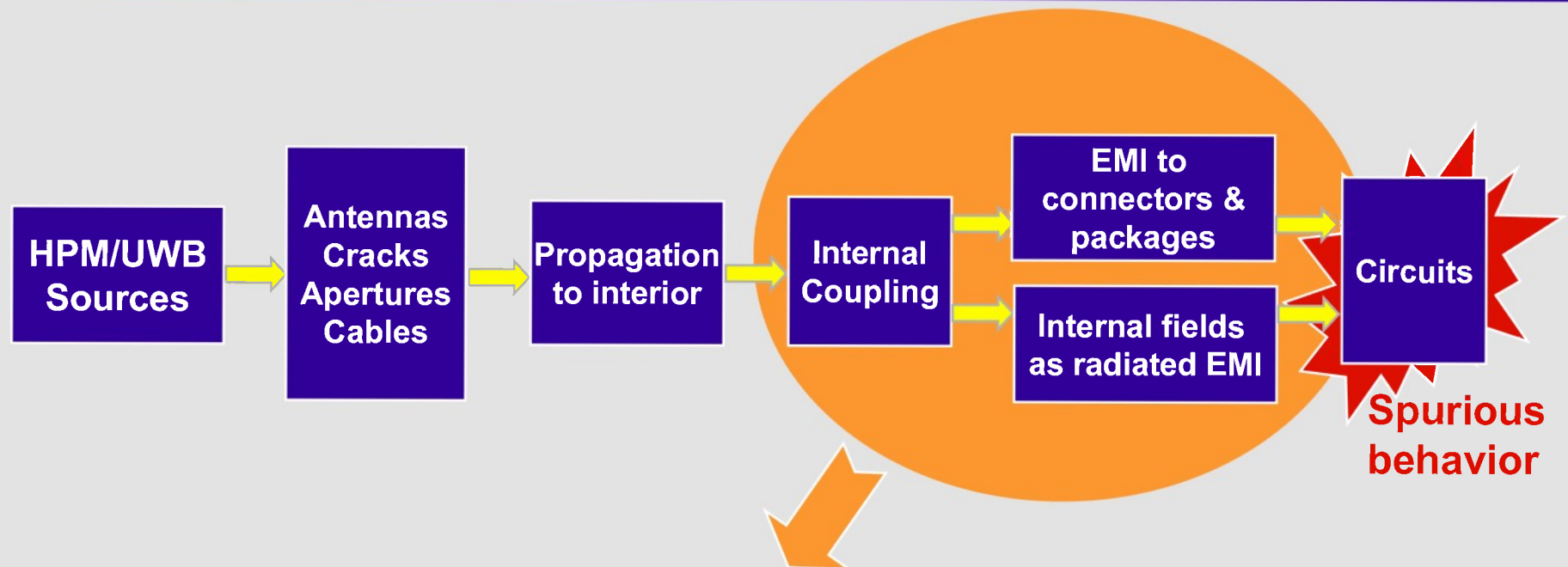
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Objective

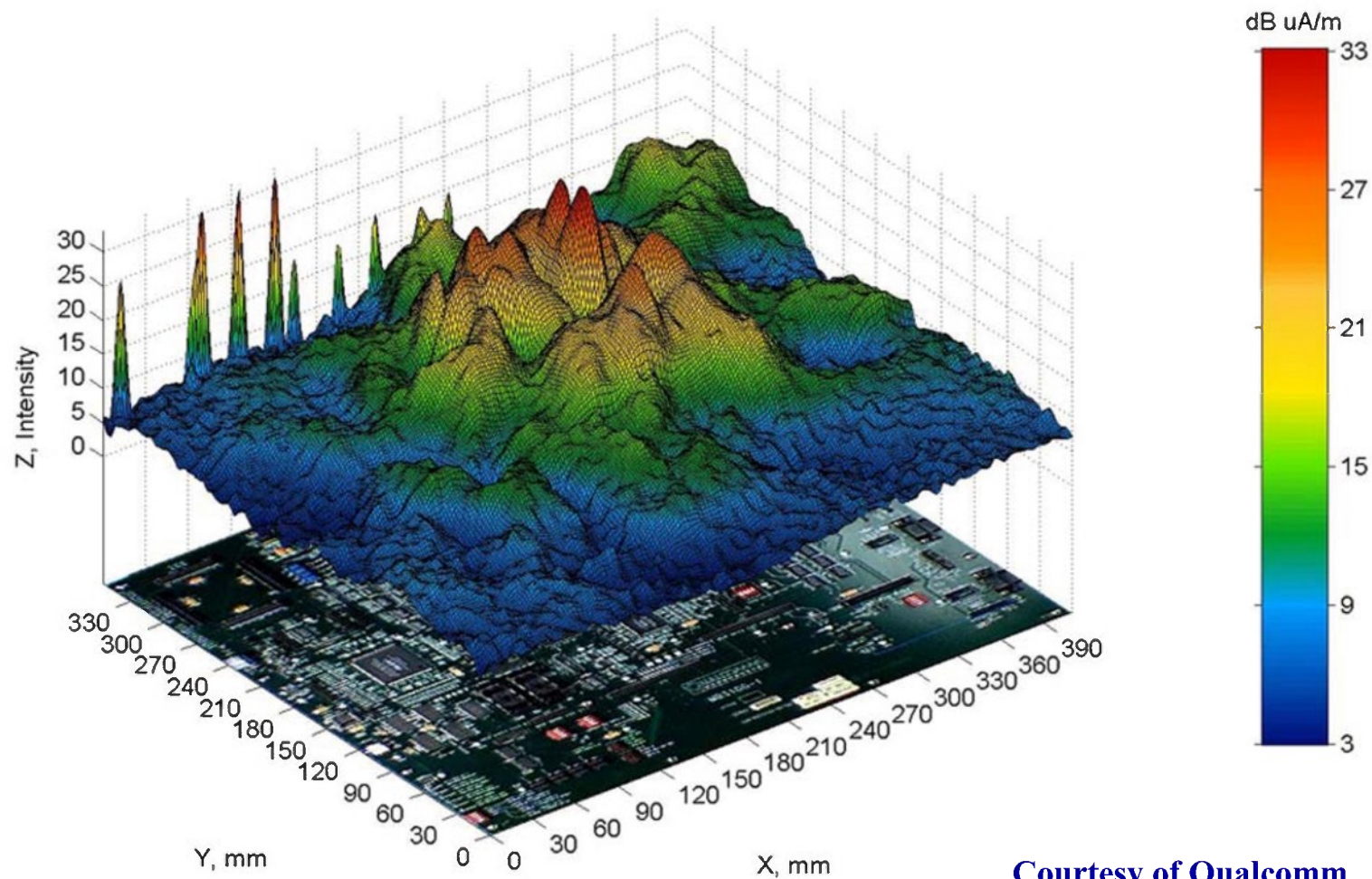


- Accurately “propagate” the spurious signals (noise) through the packaging hierarchy (printed circuit boards, cards, connectors, interposer, package...) to the die.

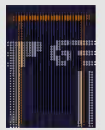


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Major Obstacle: Tackling System Complexity



Courtesy of Qualcomm



System Complexity translates to EM Complexity

■ EM Complexity

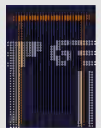
- Geometric complexity and distributed nature of the packaging hierarchy (“coupling path”)
- Broad frequency bandwidth of the interfering signal
- Non-linearity of the terminations

■ Tackling Complexity

- Hierarchical approach to the modeling of electromagnetic interactions
 - From lumped models, to transmission-line models, to quasi-3D full-wave models, to 3D full-wave models

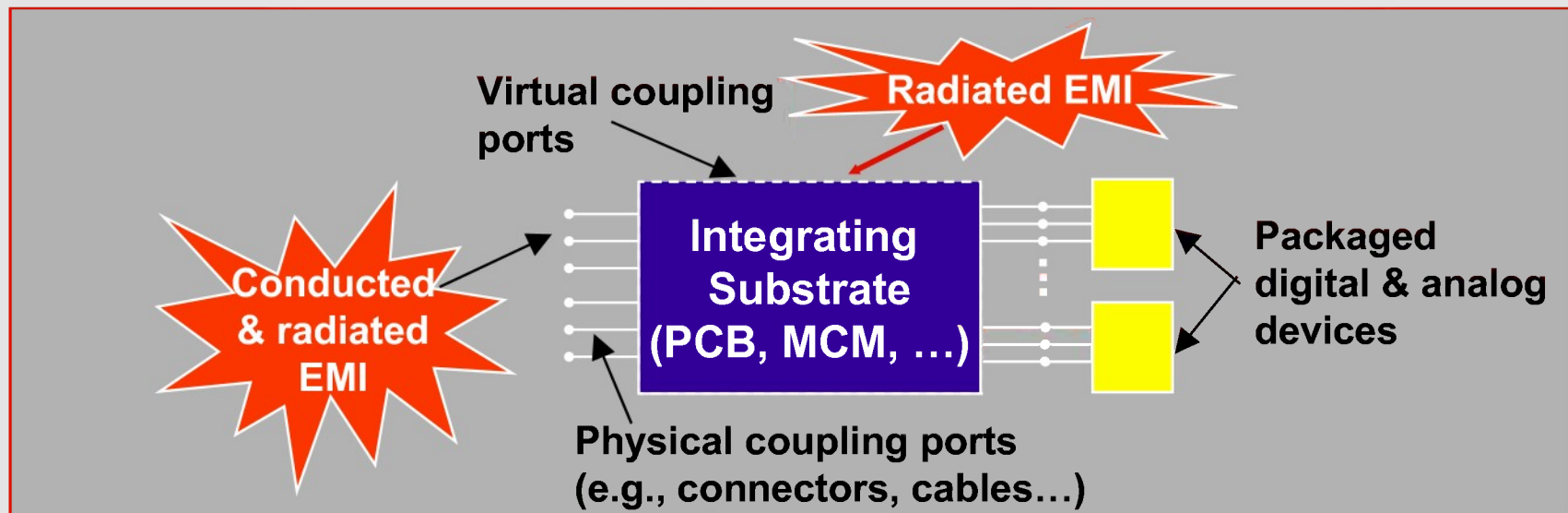
■ Abstracting Complexity

- Systematic order reduction of numerical models of the coupling path
- Equivalent circuit representation of the coupling path for its seamless incorporation in network-oriented non-linear circuit simulators

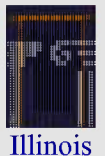
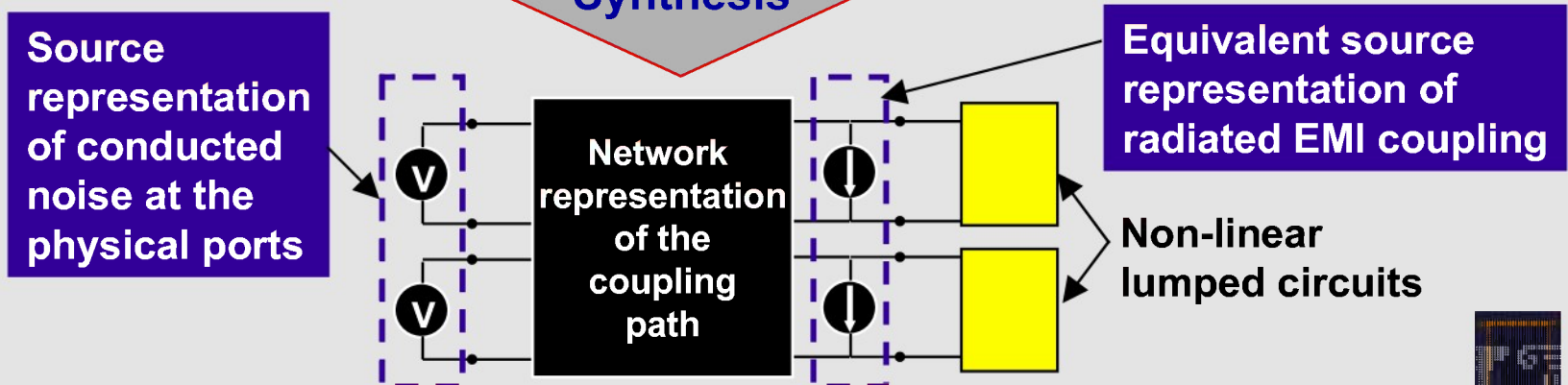


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SUMMARY OF MODELING OBJECTIVE

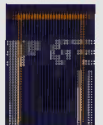


EM Modeling & Simulation Model Order Reduction Synthesis



Specific Subtasks

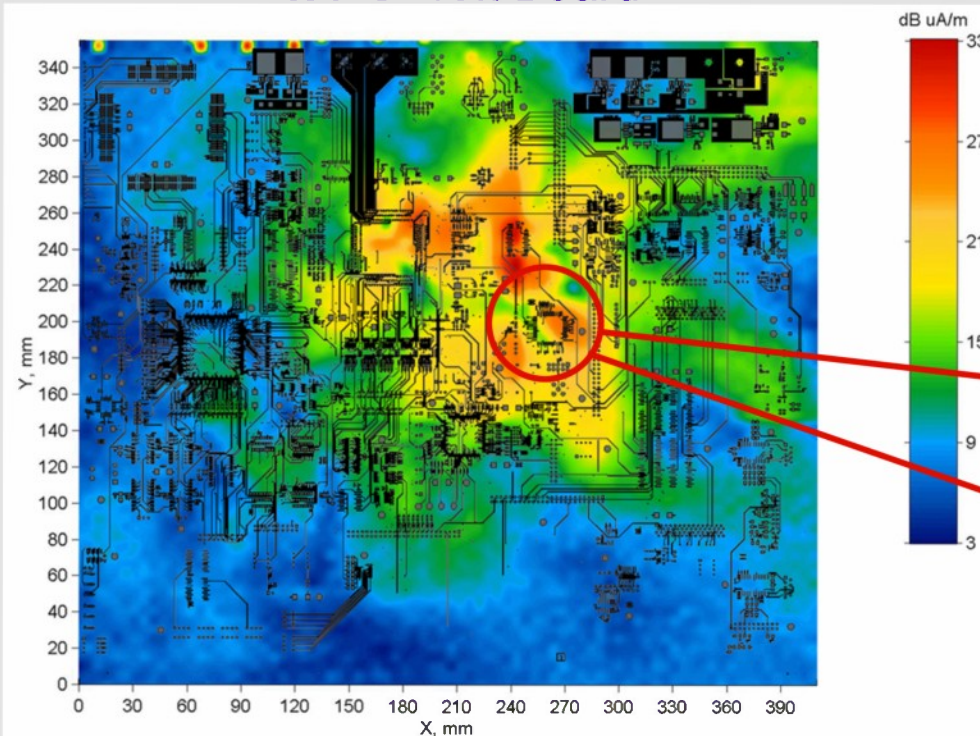
- **Task 2.1** Development of a coupling path modeling methodology
- **Task 2.2** Development of a (EMI) source modeling methodology
- **Task 2.3** Non-linear Transient Simulation of the hybrid lumped-distributed non-linear network



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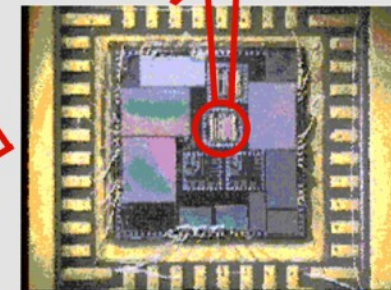
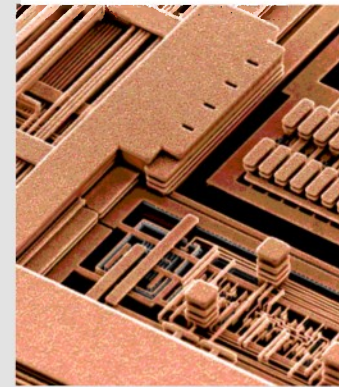
Subtask 1: Modeling of the Coupling Path

Printed Circuit Board



Chip

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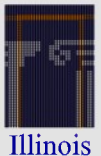
Package



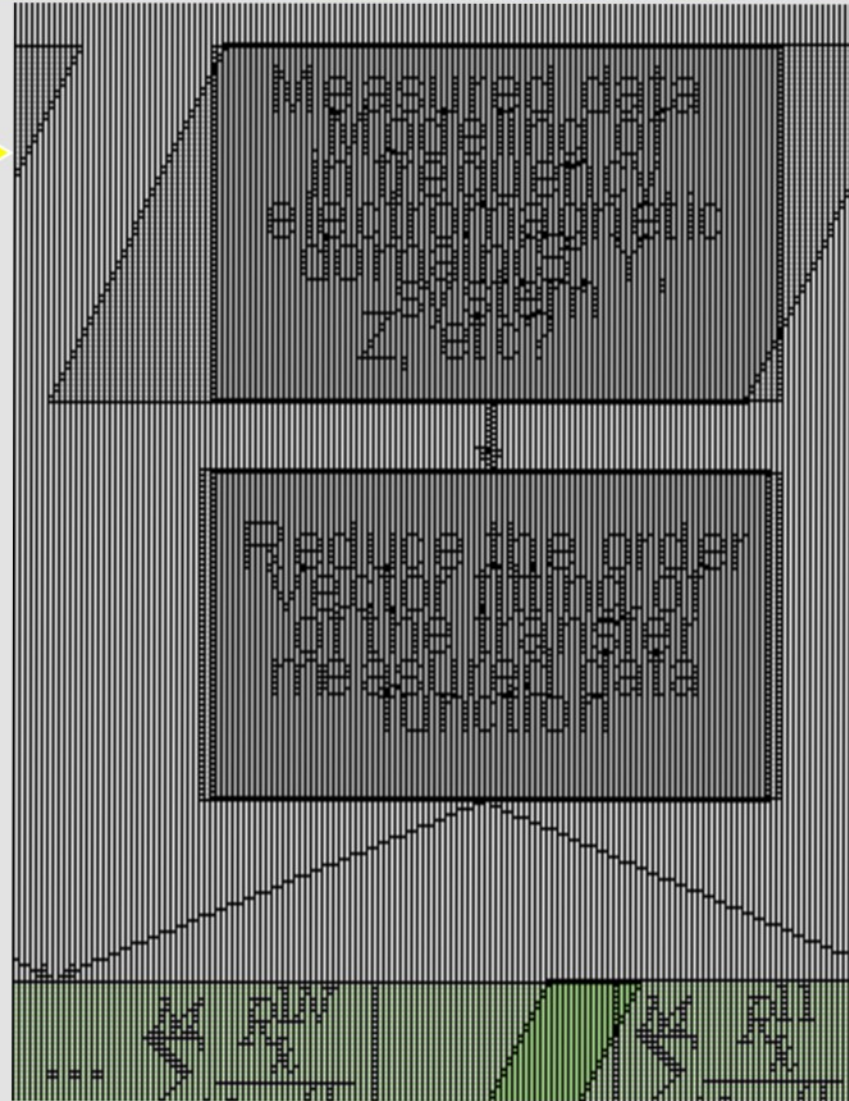
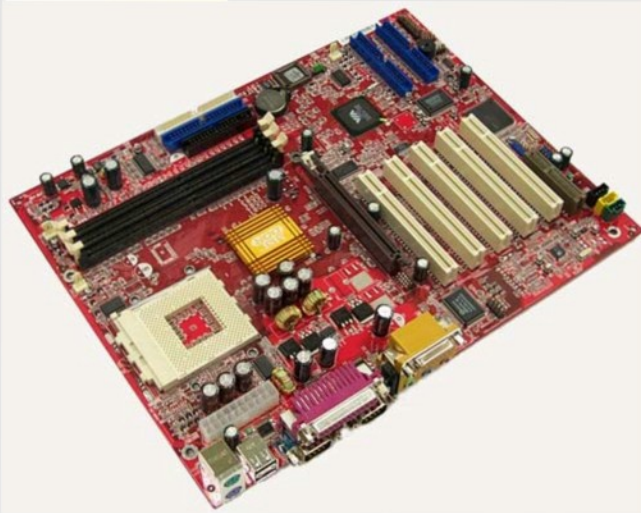
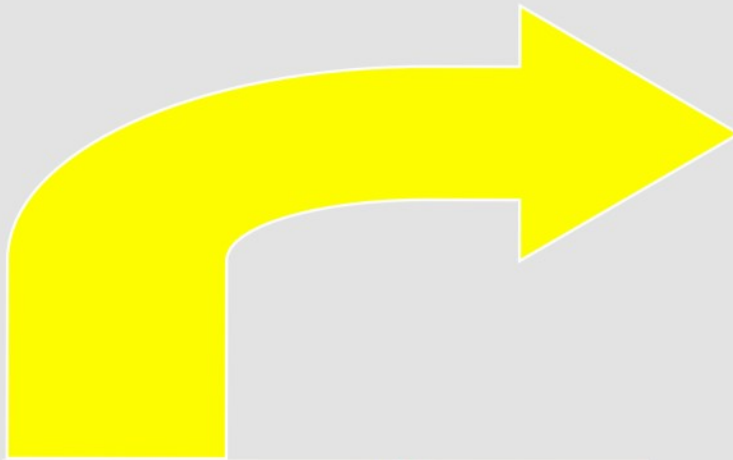
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Subtask 1: Modeling of the Coupling Path (Cont)

- Our modeling approach is hierarchical
 - EM-Physics driven “divide and conquer” approach
- Use suitable EM modeling approach for individual blocks
 - RLC models for short interconnect at chip & package level
 - Multi-conductor Transmission Lines (MTL)
 - Balanced interconnects at the board level
 - Quasi-3D EM Modeling for PCB power delivery network
 - Full-wave modeling
 - Unbalanced interconnects at the board level
 - Coupling through cables
 - RF/microwave packages & boards
- Reduction of EM models to non-linear network simulator (e.g. SPICE)
 - Direct model order reduction
 - Equivalent circuit synthesis



Block Diagram of EM Modeling Flow



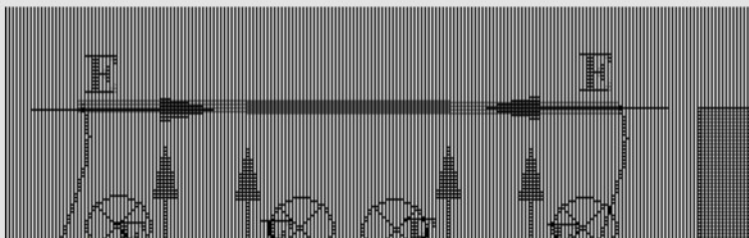
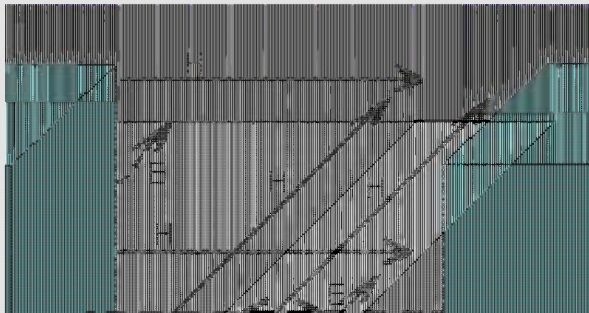
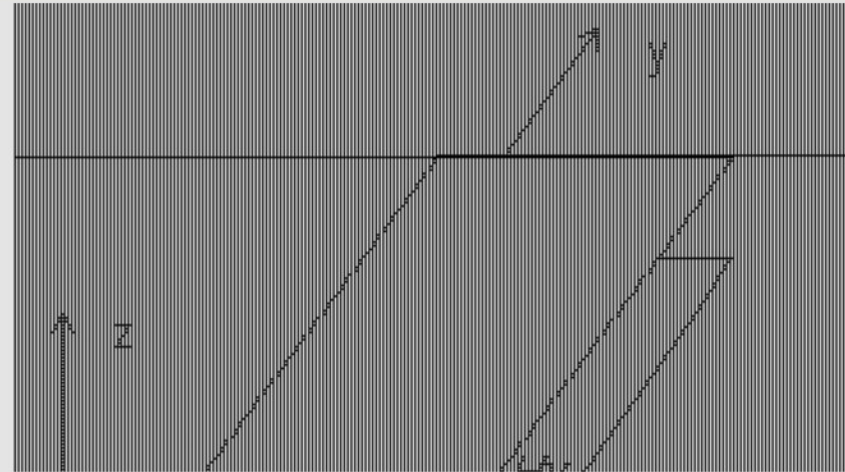
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Quasi-3D Modeling of Power Delivery Network

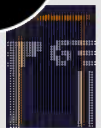
EM field between power/ground plane pairs exhibits, approximately, a two-dimensional variation

- Use simple 2D FDTD

Three-dimensional features (vias, pins, slots, voids, etc) require locally 3D models to capture the correct physics



$$\begin{aligned}
 j\omega\epsilon E_z(i, j) &= \Delta x^{-1} (H_y(i+1, j) - H_y(i, j)) \\
 &\quad - \Delta y^{-1} (H_x(i, j+1) - H_x(i, j)) \\
 -j\omega\mu\Delta y H_x(i, j) &= E_z(i, j) - E_z(i, j-1) \\
 j\omega\mu\Delta x H_y(i, j) &= E_z(i, j) - E_z(i-1, j)
 \end{aligned}$$



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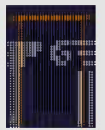
The resulting discrete EM model

$$\begin{bmatrix} \mathbf{G} & -\mathbf{D}_I \\ -\mathbf{D}_V & \mathbf{R} \end{bmatrix} \begin{bmatrix} \mathbf{E}(s) \\ \mathbf{H}(s) \end{bmatrix} + s \begin{bmatrix} \mathbf{C} & \mathbf{0} \\ \mathbf{0} & \mathbf{L} \end{bmatrix} \begin{bmatrix} \mathbf{E}(s) \\ \mathbf{H}(s) \end{bmatrix} = \mathbf{F}\mathbf{U}(s), \quad \mathbf{V} = \mathbf{F}^T \mathbf{X}$$

$$\mathbf{V}(s) = \mathbf{F}^T (\mathbf{A} + s\mathbf{B})^{-1} \mathbf{F}\mathbf{U}(s) \text{ where } \mathbf{A} = \begin{bmatrix} \mathbf{G} & -\mathbf{D}^T \\ \mathbf{D} & \mathbf{R} \end{bmatrix}, \quad \mathbf{B} = \begin{bmatrix} \mathbf{C} & \mathbf{0} \\ \mathbf{0} & \mathbf{L} \end{bmatrix}$$

The multiport transfer function is: $\mathbf{Y}(s) = \mathbf{F}^T (\mathbf{A} + s\mathbf{B})^{-1} \mathbf{F}$

- Direct time-domain simulation is possible if desired
 - Could be synchronized with time-domain IE solver
- Alternatively, model order reduction of the transfer function using an Arnoldi-based subspace iteration method (PRIMA) is used for the generation of a compact multiport



Multi-port representation of the reduced-order model is in terms of rational functions

$$\mathbf{Y}(s) = \begin{bmatrix} \sum_{k=1}^M \frac{R_k^{11}}{s - P_k} & \cdots & \sum_{k=1}^M \frac{R_k^{1N}}{s - P_k} \\ \vdots & \cdot & \vdots \\ \sum_{k=1}^M \frac{R_k^{N1}}{s - P_k} & \cdots & \sum_{k=1}^M \frac{R_k^{NN}}{s - P_k} \end{bmatrix}$$

- Form compatible with circuit simulators that support rational function models (e.g. H-Spice, ADS)
- Equivalent circuit synthesis is possible also



Passive synthesis through Foster forms

For a passive, reciprocal multi-port, its admittance (or impedance) matrix may be cast in the following form:

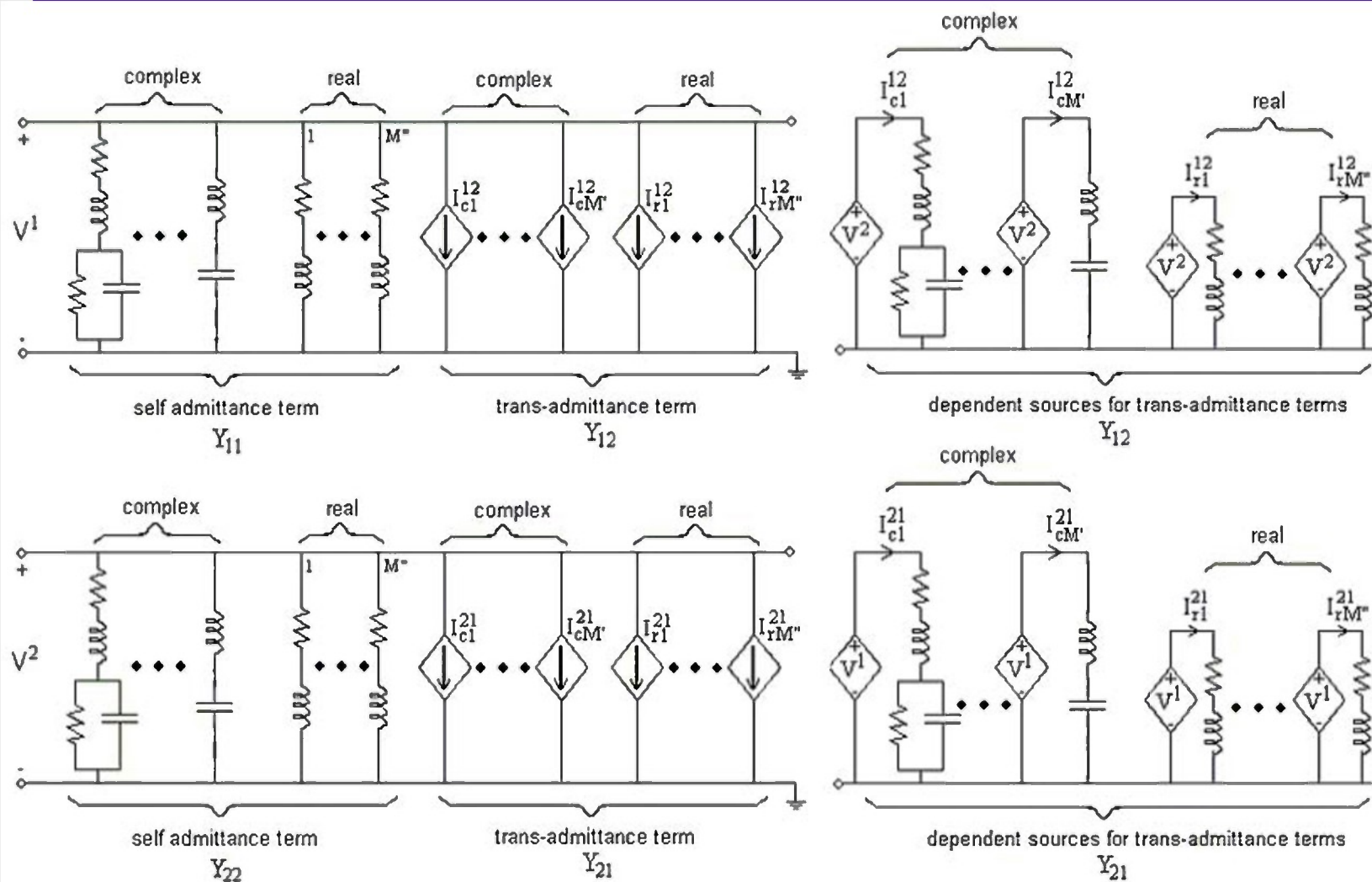
$$\mathbf{H}(s) = \mathbf{G}_0 + s\mathbf{C}_0 + \sum_{q=1}^Q \left(\frac{a_q}{s - p_q} + \frac{\bar{a}_q}{s - \bar{p}_q} \right) \mathbf{G}_q$$

where it is:

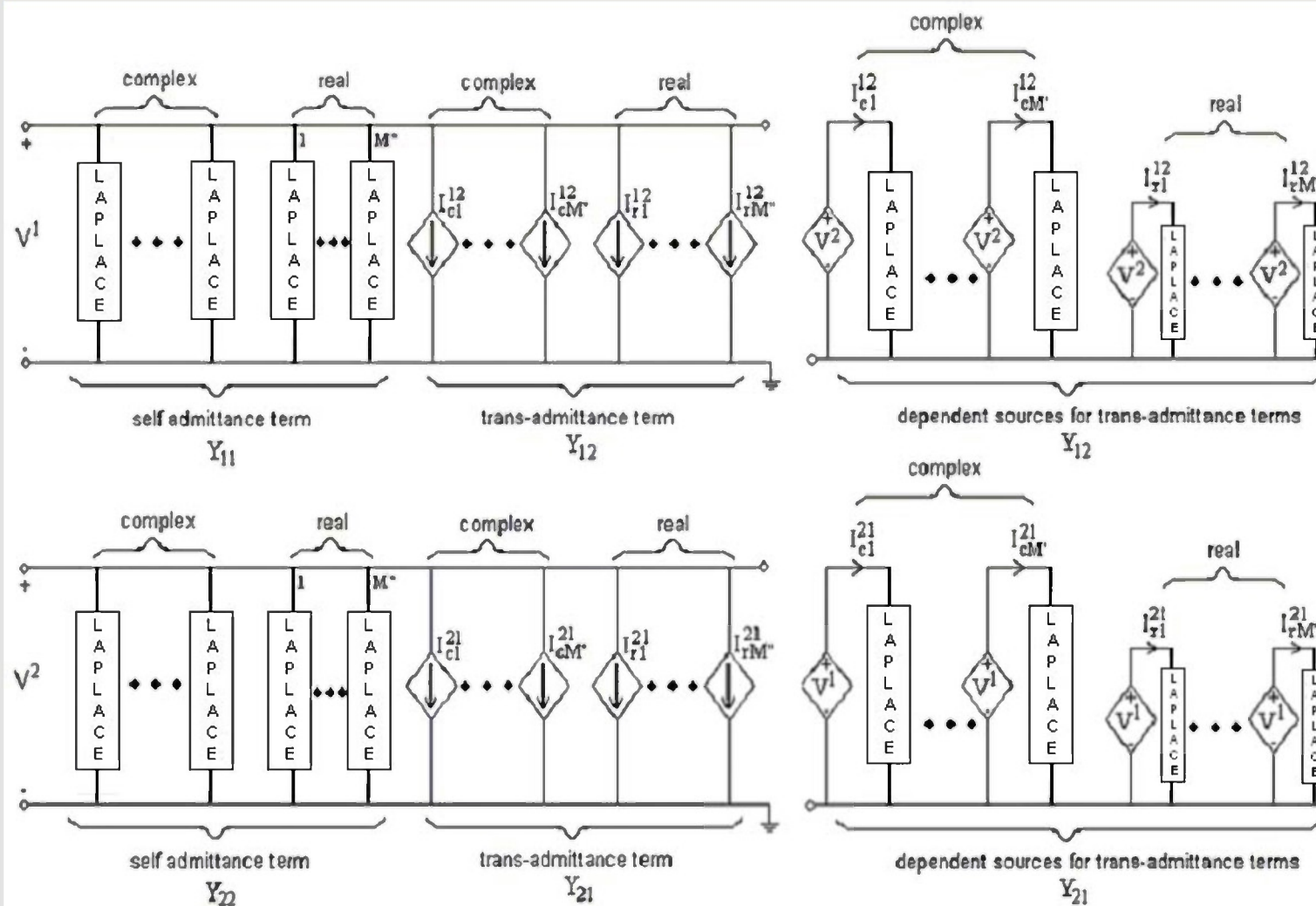
- $\operatorname{Re}\{p_q\} \leq 0, \quad q = 1, 2, \dots, Q$
- matrices \mathbf{C}_0 and $\mathbf{G}_q, \quad q = 0, 1, 2, \dots, Q$, are real and positive semi-definite
- $\operatorname{Re}\{a_q\} > 0, \quad q = 1, 2, \dots, Q$
- $0 < \operatorname{Im}\{a_q\} \operatorname{Im}\{p_q\} \leq |\operatorname{Re}\{a_q\} \operatorname{Re}\{p_q\}|, \quad q = 1, 2, \dots, Q$



Equivalent circuit for a two-port



Two-port sub-circuit for use in H-SPICE



The advantages of the direct use of the rational function macro-model in the simulator

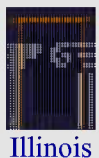
Elapsed Simulation Time

	3 ports	10 ports	36 ports
H-SPICE	0.7 sec	5.73 sec	21.2 min
Equivalent	2.3 sec	676.55 sec	>12 hours

Transient Data File Size

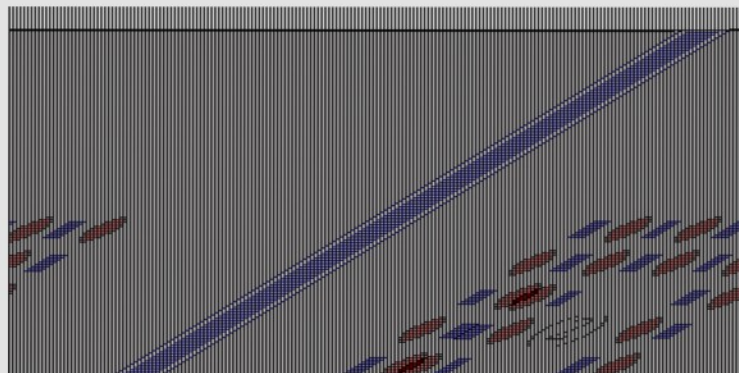
	3 ports	10 ports	36 ports
H-SPICE	25.9 KB	53.4 KB	172 KB
Equivalent	308.2 KB	269 MB	>2 GB

The secret is in the recursive convolution that is utilized for the interfacing of the macro-model with the rest of the circuit

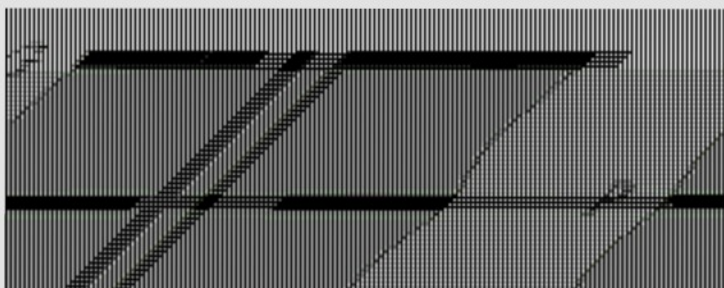


Application to a 4-layer PCB

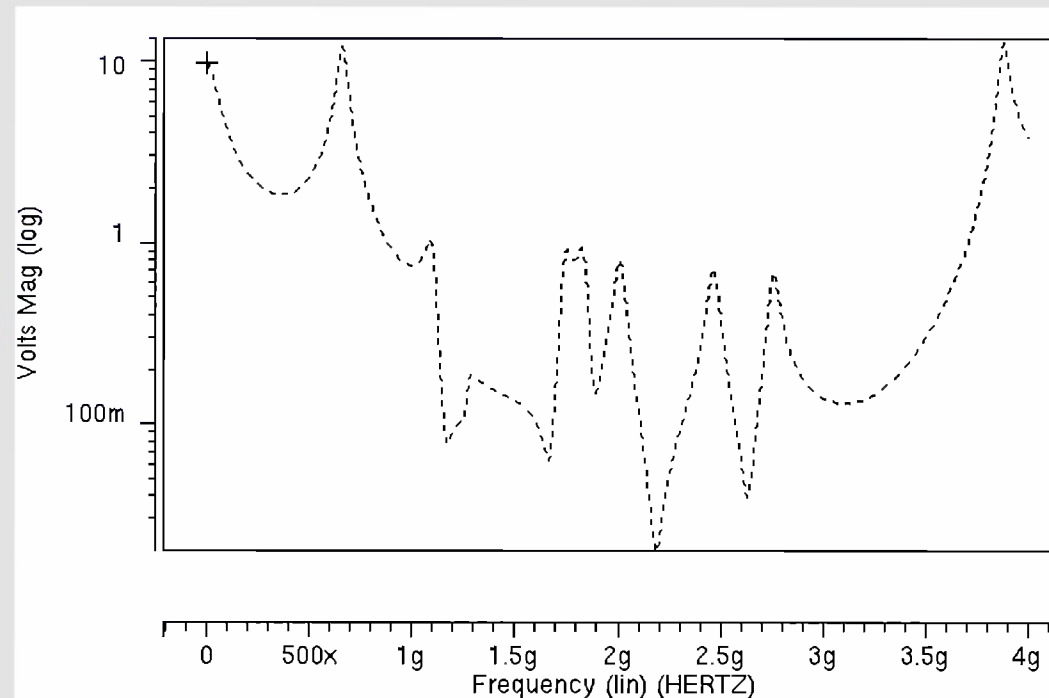
8 cm X 4 cm, 4 layer board. A 2mm gap is present all the way across the top ground plane. A total of 58 pins are used.



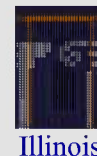
Top view



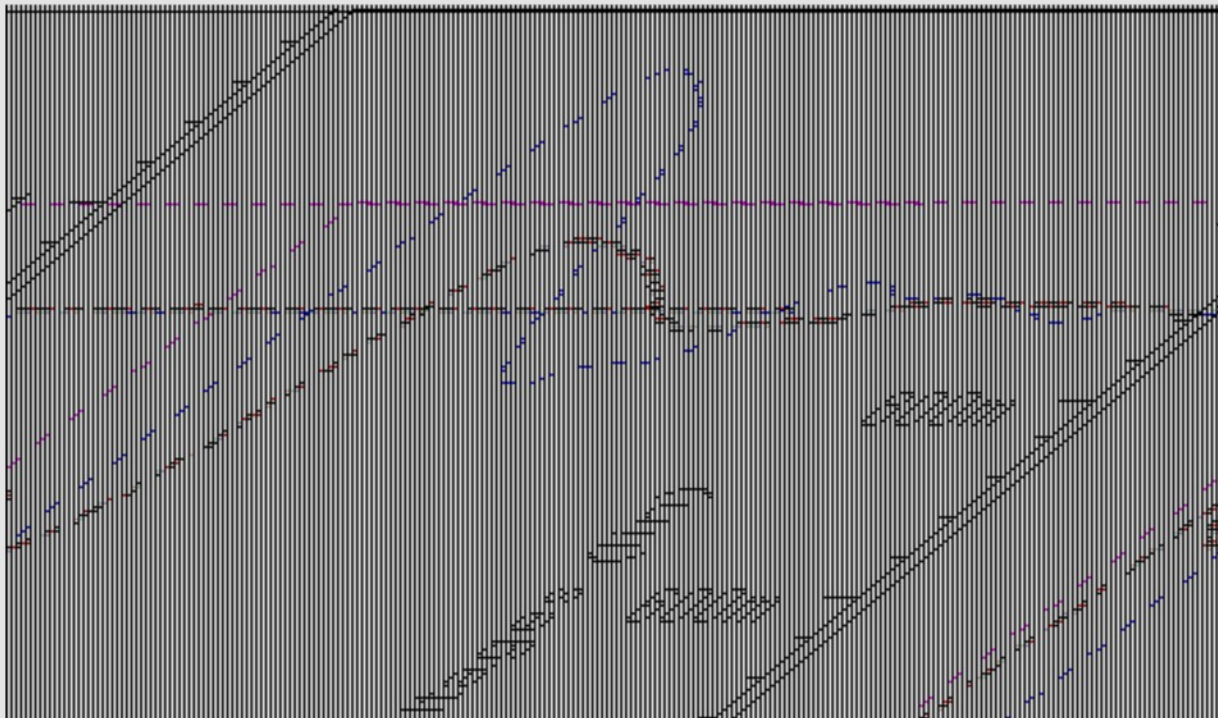
Cross-sectional view



|Z₂₁| From H-SPICE



Application to a 4-layer PCB (cont'd)



H-SPICE calculation of the transient response.

Switching occurs at port 1 while port 2 is terminated with 50ohm.

Voltage at port 1 is depicted by the solid line.

Voltage at port 2 is depicted by the dotted line.



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Validation study in progress

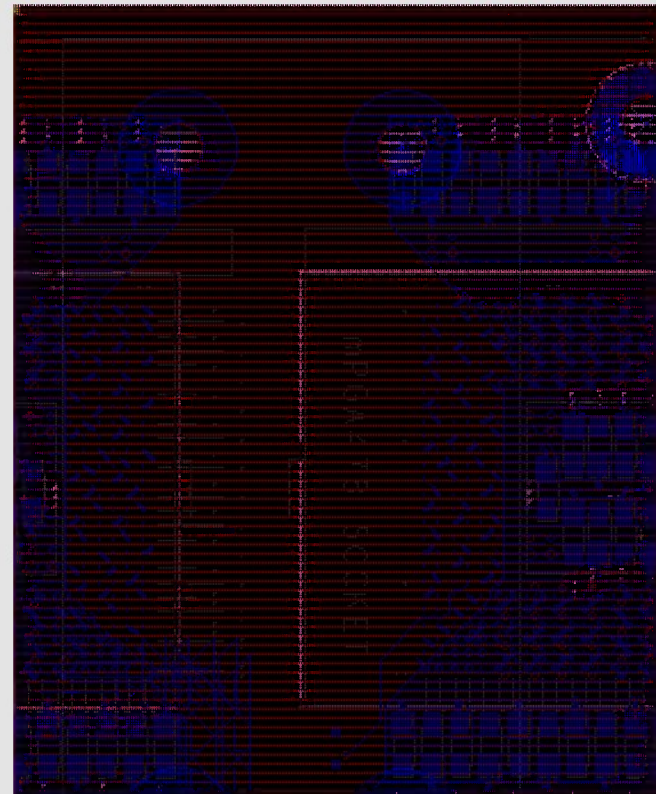
Intel 4-layer test board

1st layer: Power plane

2nd layer: Ground plane

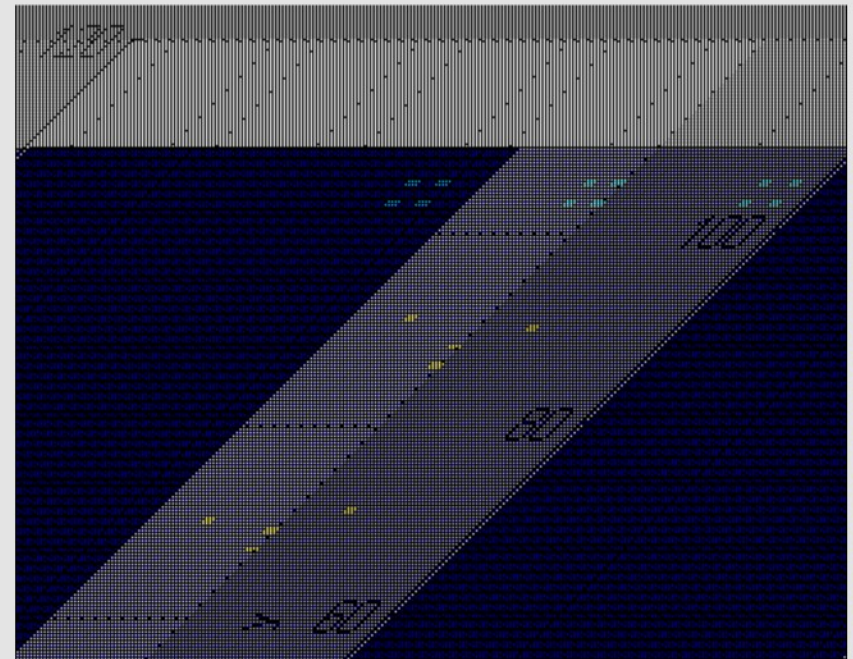
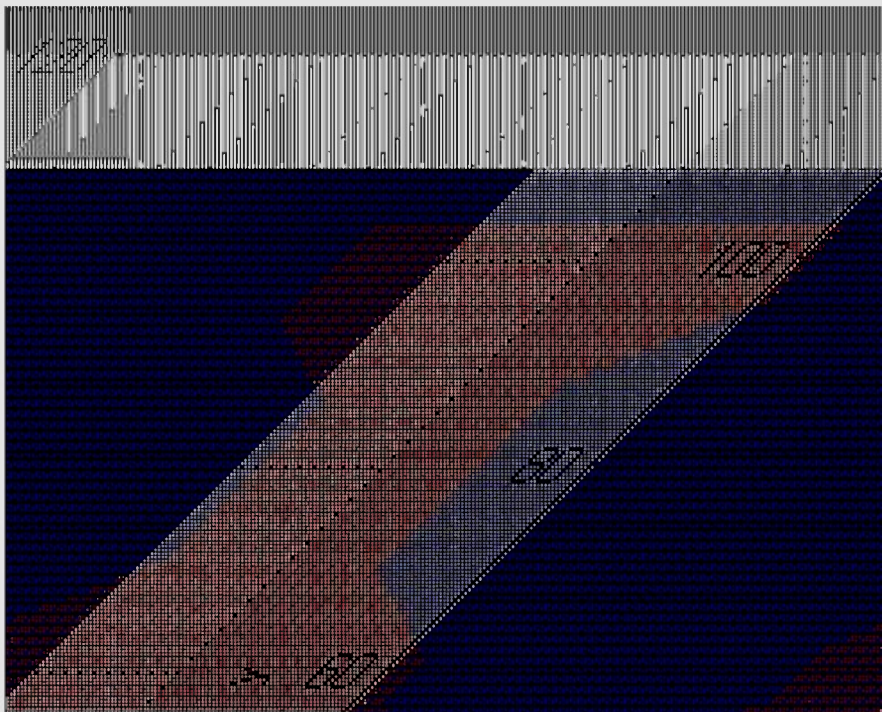
3rd layer: Ground plane

4th layer: Power plane



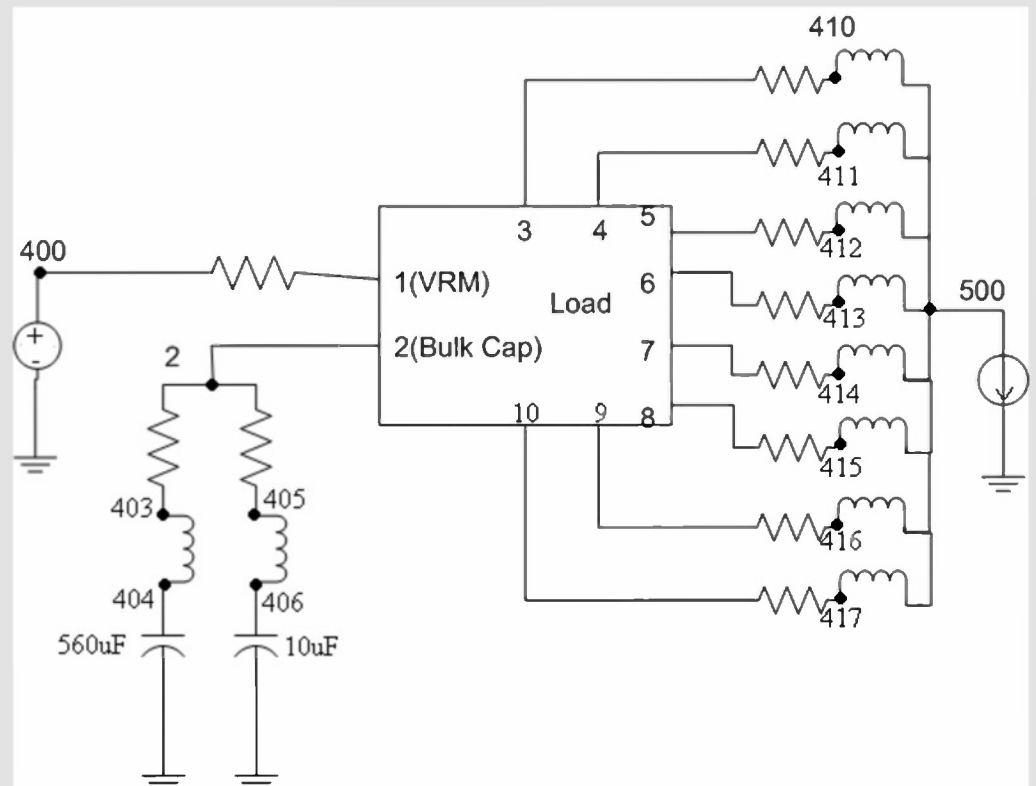
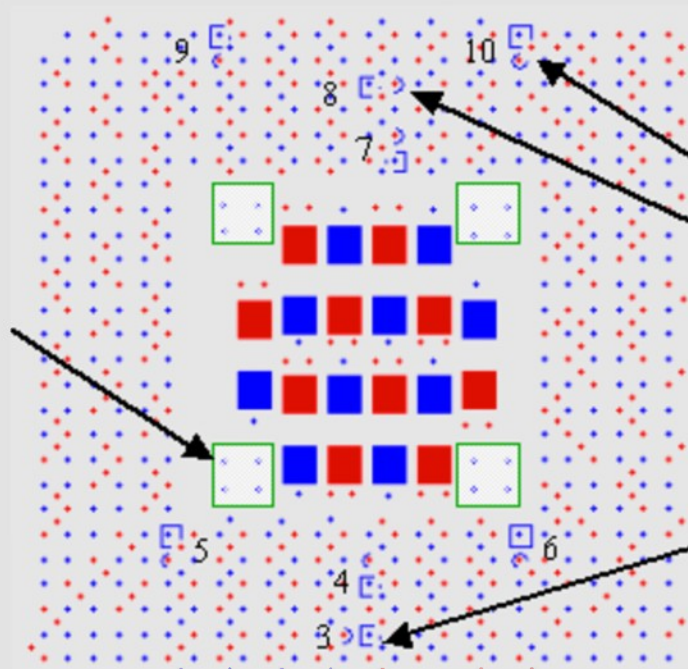
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Samples of the generated mesh



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Generated multi-port for switching noise simulation in SPICE



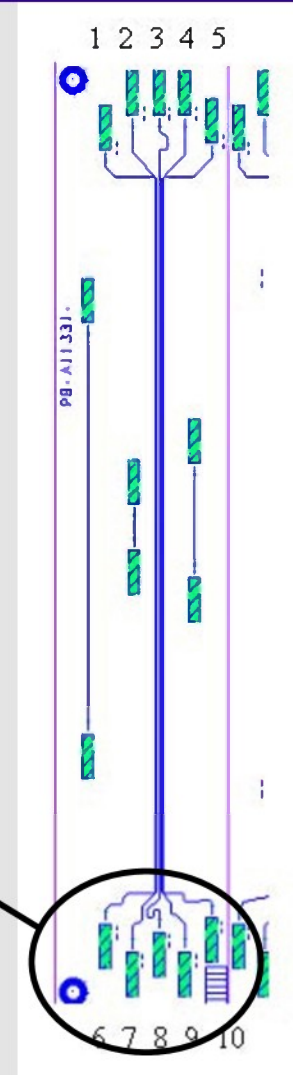
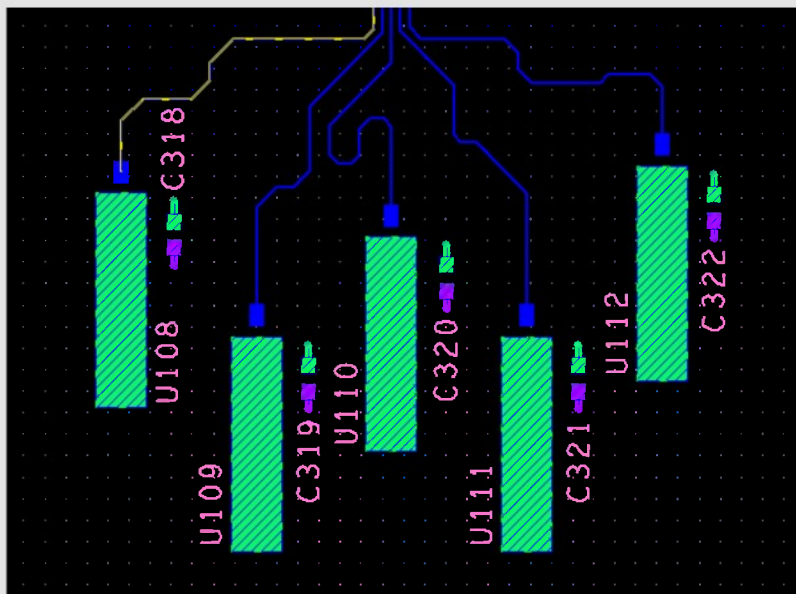
Rational function multi-port & equivalent circuit synthesis from raw data

- Data either from measurements or EM field solvers
- Step 1: Rational function fitting
 - Process guarantees stability but not passivity
 - Check fitted multi-port for passivity
 - If not passive, constrain fitting using Foster constraints
 - Repeat fitting



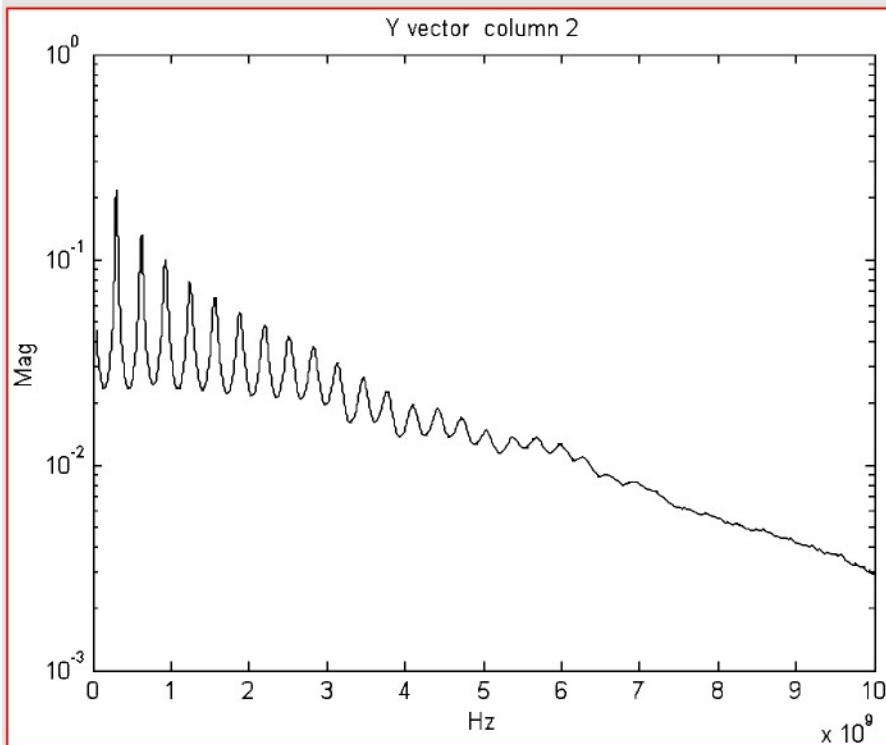
Validation of rational function fitting

PCB interconnect test structures courtesy of Intel

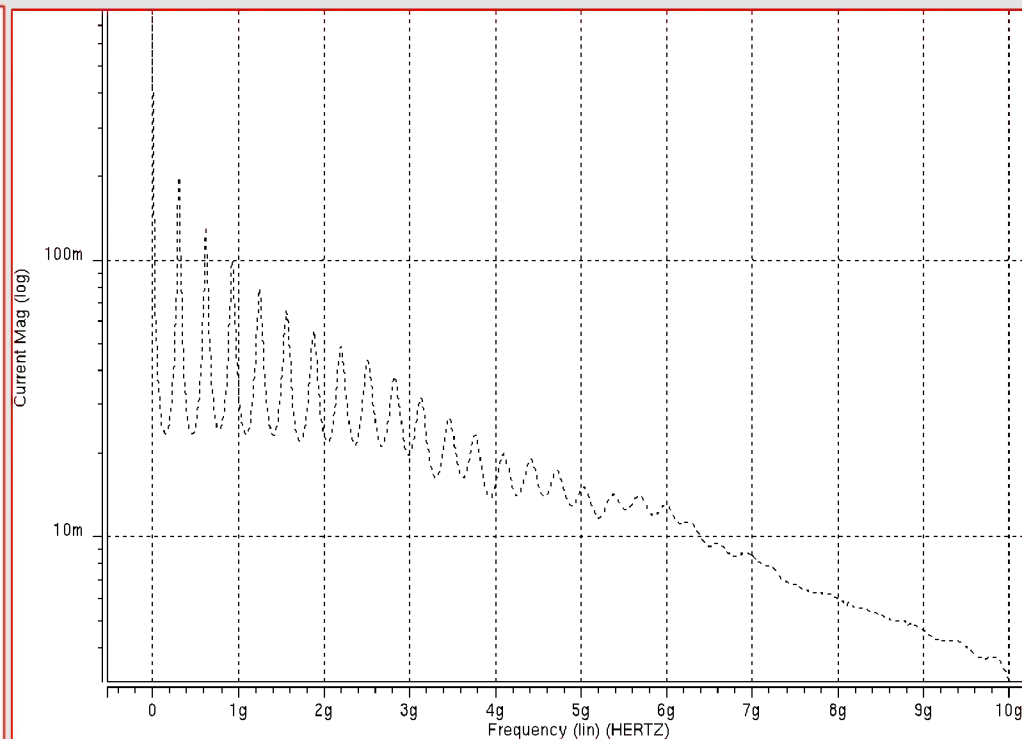


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Validation of fitting (cont'd)

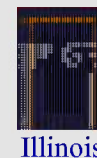


Measured $|Y_{61}|^*$



Synthesized $|Y_{61}|$

(*) Measurements courtesy of Intel Corporation

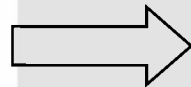


Task 2.1 Summary

- EM modeling flow for the coupling path established
- Quasi-3D EM Model for power delivery network completed
 - Validation in progress
 - Further enhancements include:
 - Incorporation of hooks for balanced MTLs
 - Incorporation of hooks for matrix transfer functions in Foster form
- Capability for SPICE-compatible broadband multi-port macro-model generation in place



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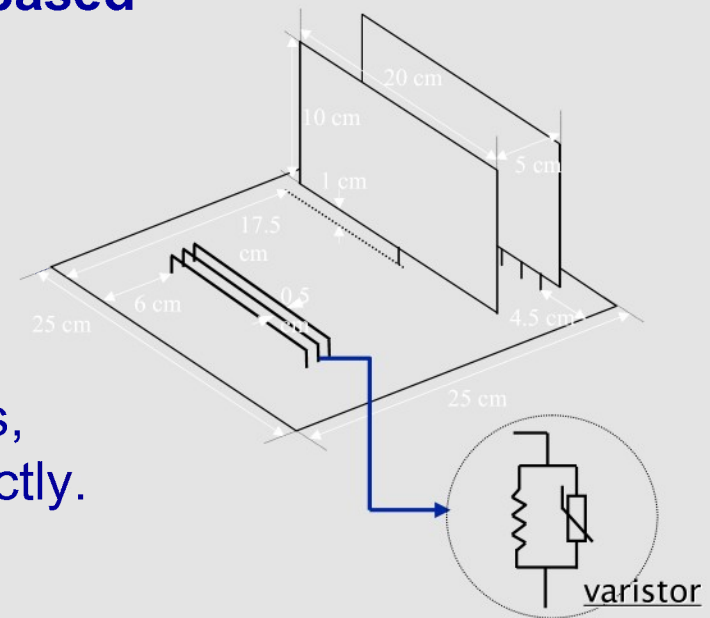


Introduction (cont.)

- **Time Domain Integral Equation (TDIE) based Marching-on-in-time (MOT) solvers**

- Have been known to the acoustics and electromagnetics communities since the sixties.
- Compared to frequency domain solvers, they can solve nonlinear problems directly.

Liu and Tesche (1976),
Landt and Miller (1983),
Djordjevic and Sarkar (1985),
Deiseroth and Singer (1995),
Orlandi (1996)



Introduction (cont.)

However TDIE - MOT solvers have long been conceived as

- **Unstable:** ... But recently many proposals have surfaced for stabilizing these schemes (Davies, Rao and Sarkar, Walker, Smith, Rynne,...);
- **Slow:** ... Computational complexity has prohibited application to analysis of large scale problems!
... **PWTD** technology removes this computational bottleneck

$$O(N_T N_S^2)$$

$$O(N_T N_S \log^2 N_S)$$

Now, we can / should be able to rapidly solve **large-scale, nonlinear** problems using the PWTD technology!!!



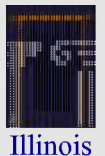
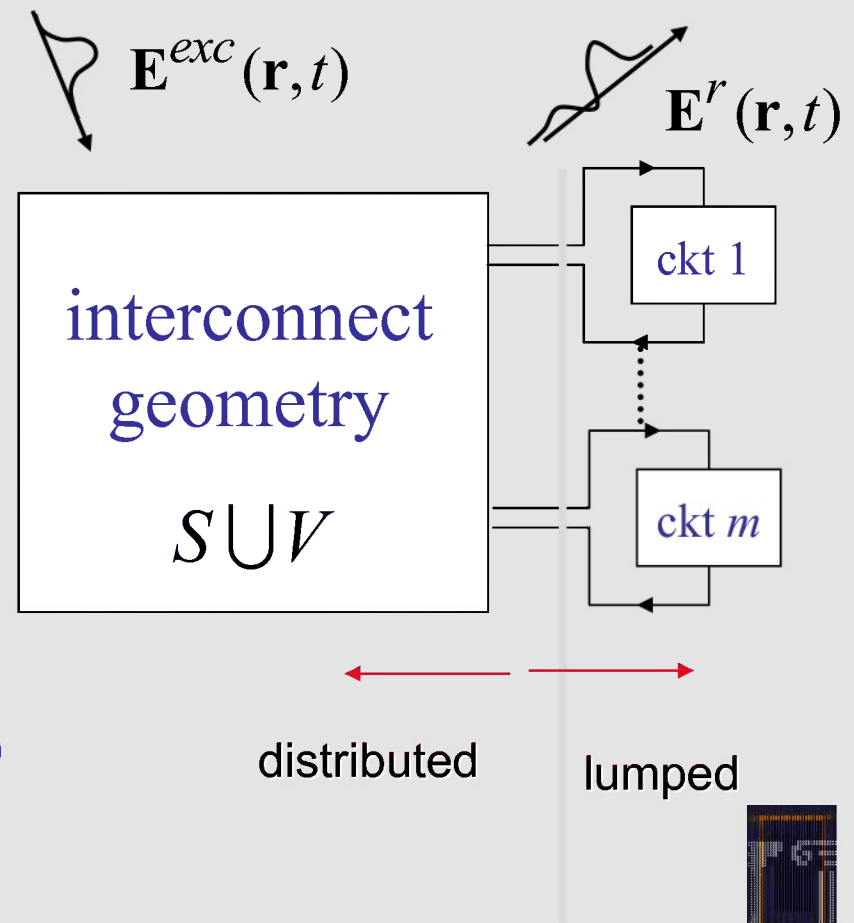
Formulation - Problem Definition

■ Given

- an of 3-D inhomogeneous dielectric bodies (V), and 3-D arbitrarily shaped PEC surfaces, wires, and surface-wire junctions (S),
- Multiple linear / nonlinear lumped circuits connected to $S \cup V$
- a temporally bandlimited excitation

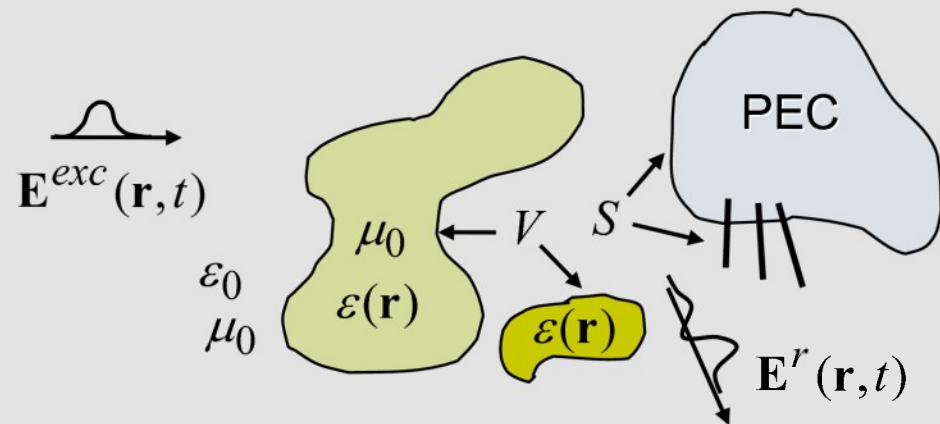
■ Solve for

- all transient currents and voltages induced on the interconnect geometry $S \cup V$ and the the circuits (ckt 1, ..., ckt m)
- radiated electric and/or magnetic fields if required



Formulation – Time Domain Electric Field

- Assume spatially-variable, frequency independent permittivity and free-space permeability in V , and thin wires in S .
- Radiated electric field:



$$\mathbf{E}^r(\mathbf{r}, t) = -\frac{\partial}{\partial t} \mathbf{A}(\mathbf{r}, t) + c^2 \int_0^t dt' \nabla \nabla \cdot \mathbf{A}(\mathbf{r}, t') \quad (1)$$

$$\mathbf{A}(\mathbf{r}, t) = \frac{\mu_0}{4\pi} \left[\int_S ds' \frac{\delta(t - R/c)}{R} * \mathbf{J}_{PEC}(\mathbf{r}', t) + \int_V dv' \frac{\delta(t - R/c)}{R} * \mathbf{J}_{DIEL}(\mathbf{r}', t) \right], \quad (2)$$

$$R = |\mathbf{r} - \mathbf{r}'|, \quad \mathbf{J}_{DIEL}(\mathbf{r}, t) = (\epsilon(\mathbf{r}) - \epsilon_0) \frac{\partial}{\partial t} \mathbf{E}^{total}(\mathbf{r}, t)$$

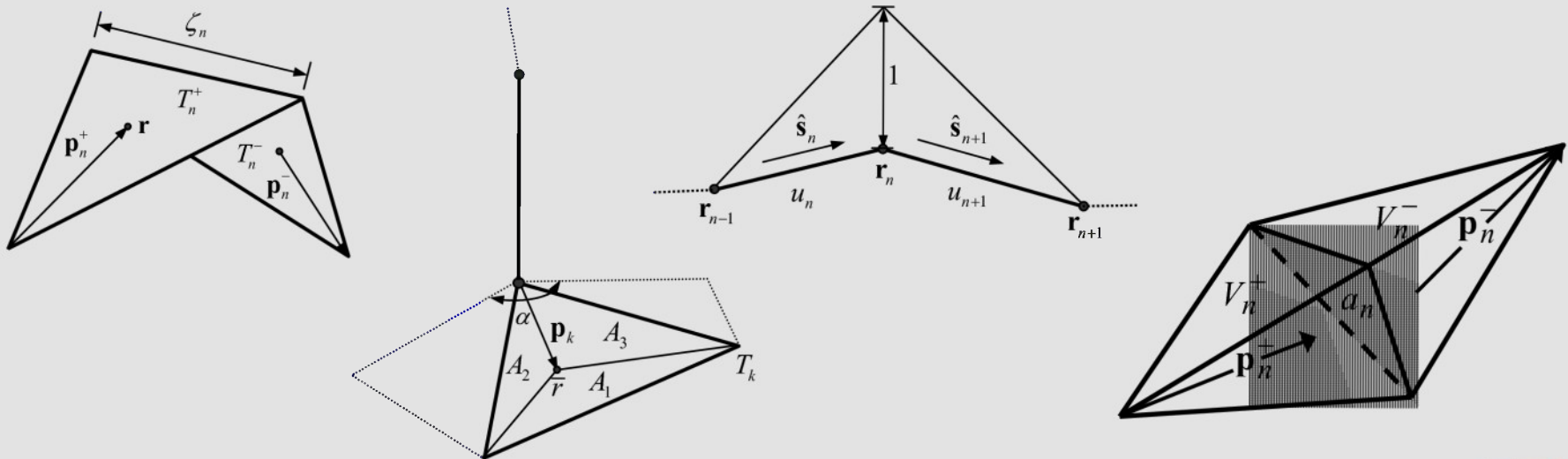


Formulation - MOT Algorithm

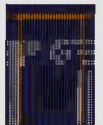
① Expand current as
$$\mathbf{J}(\mathbf{r}, t) \approx \sum_{n=1}^{N_S} \sum_{j=0}^{N_T} I_n^j \mathbf{f}_n^q(\mathbf{r}) T_j(t), \quad q = s, w, sw, d$$

$$N_S = N_{PEC} + N_{DIEL}$$

■ Surface and Volume Spatial Basis Functions



■ The temporal basis functions are local cubic polynomials

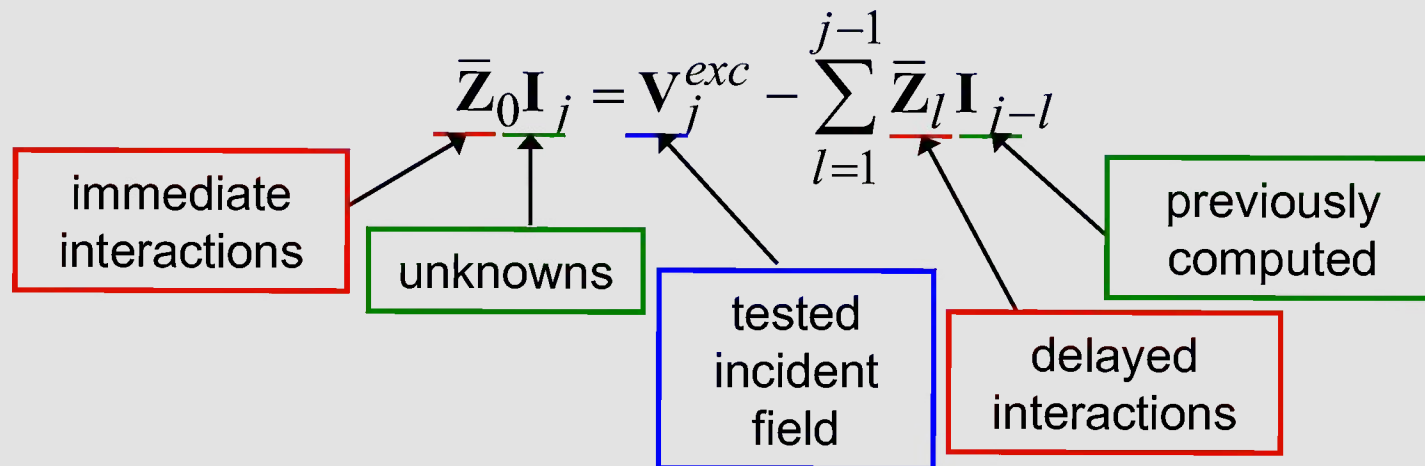


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Formulation - MOT Algorithm (cont.)

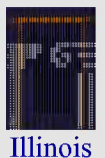
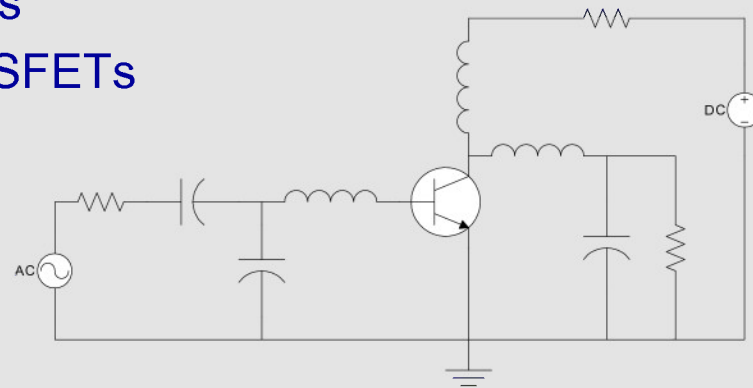
- ② Construct a system of equations by applying spatial Galerkin testing at each time step.

- for the j 'th time step:



Formulation - Transient Circuit Simulator

- **SPICE-like transient circuit simulator**
 - Performs linear and nonlinear large-signal analysis using Modified nodal analysis
 - Nonlinear equations solved using multi-dimensional Newton
 - Incorporates the following circuit elements:
 - Independent/dependent voltage and current sources
 - Resistors, inductors, capacitors
 - Diodes, BJTs, MOSFETs, MESFETs



Formulation - Transient Circuit Simulator (cont.)

- Circuit behavior described by time-domain nodal equations (using trapezoidal rule for the j th time step)

$$\underline{\mathbf{G}}_0(\underline{\mathbf{V}}_j) = \underline{\mathbf{I}}_j^{exc} + \underline{\mathbf{G}}_1(\underline{\mathbf{V}}_{j-1})$$

Diagram illustrating the nodal equation for the j th time step:

- $\underline{\mathbf{G}}_0(\underline{\mathbf{V}}_j)$: immediate interactions (red box)
- $\underline{\mathbf{V}}_j$: unknowns (green box)
- $\underline{\mathbf{I}}_j^{exc}$: sources (blue box)
- $\underline{\mathbf{G}}_1(\underline{\mathbf{V}}_{j-1})$: interactions from previous time step (red box)
- $\underline{\mathbf{V}}_{j-1}$: previously computed (green box)

- For m circuits, the nonlinear system of equations is

$$\tilde{\mathbf{G}}_0(\tilde{\mathbf{V}}_j) = \begin{bmatrix} \mathbf{G}_0^1(\mathbf{V}_j^1) \\ \vdots \\ \mathbf{G}_0^m(\mathbf{V}_j^m) \end{bmatrix} = \begin{bmatrix} \mathbf{I}_j^{exc,1} \\ \vdots \\ \mathbf{I}_j^{exc,m} \end{bmatrix} + \begin{bmatrix} \mathbf{G}_1^1(\mathbf{V}_{j-1}^1) \\ \vdots \\ \mathbf{G}_1^m(\mathbf{V}_{j-1}^m) \end{bmatrix} = \tilde{\mathbf{I}}_j^{exc} + \tilde{\mathbf{G}}_1(\tilde{\mathbf{V}}_{j-1})$$

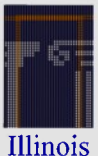


Formulation - Coupled EM / Circuit Equations

- Combine the EM and circuit nodal equations into a single consistent system to be solved for N_S EM and N_C circuit unknowns at each time step

$$\begin{bmatrix} \bar{\mathbf{Z}}_0 & \bar{\mathbf{C}}_v \\ \bar{\mathbf{C}}_i & 0 \end{bmatrix} \begin{bmatrix} \mathbf{I}_j \\ \tilde{\mathbf{V}}_j \end{bmatrix} + \begin{bmatrix} 0 \\ \tilde{\mathbf{G}}_0(\tilde{\mathbf{V}}_j) \end{bmatrix} = \begin{bmatrix} \mathbf{V}_j^{exc} - \sum_{l=1}^{j-1} \mathbf{Z}_l \mathbf{I}_{j-l} \\ \tilde{\mathbf{I}}_j^{exc} + \tilde{\mathbf{G}}_1(\tilde{\mathbf{V}}_{j-1}) \end{bmatrix}$$

- Coupling between the circuits and the interconnect structure is accounted for by matrices $\bar{\mathbf{C}}_v$ and $\bar{\mathbf{C}}_i$

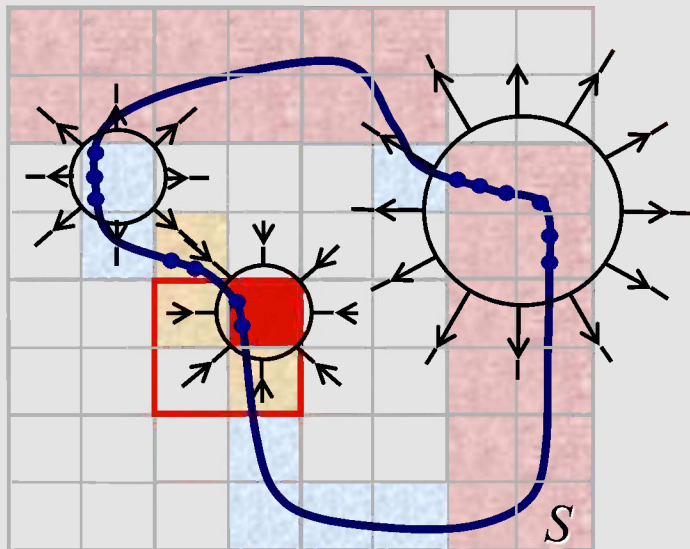








Formulation - the MLPWTD Algorithm

$$\bar{\mathbf{Z}}_0 \mathbf{I}_j = \mathbf{V}_j^{exc} - \sum_{l=1}^{j-1} \bar{\mathbf{Z}}_l \mathbf{I}_{j-l}$$

$$O(N_T N_S \log^2 N_S)$$

for typical PCB
structures



Level	Direct(0)	1	2
Source block			
Observer block			

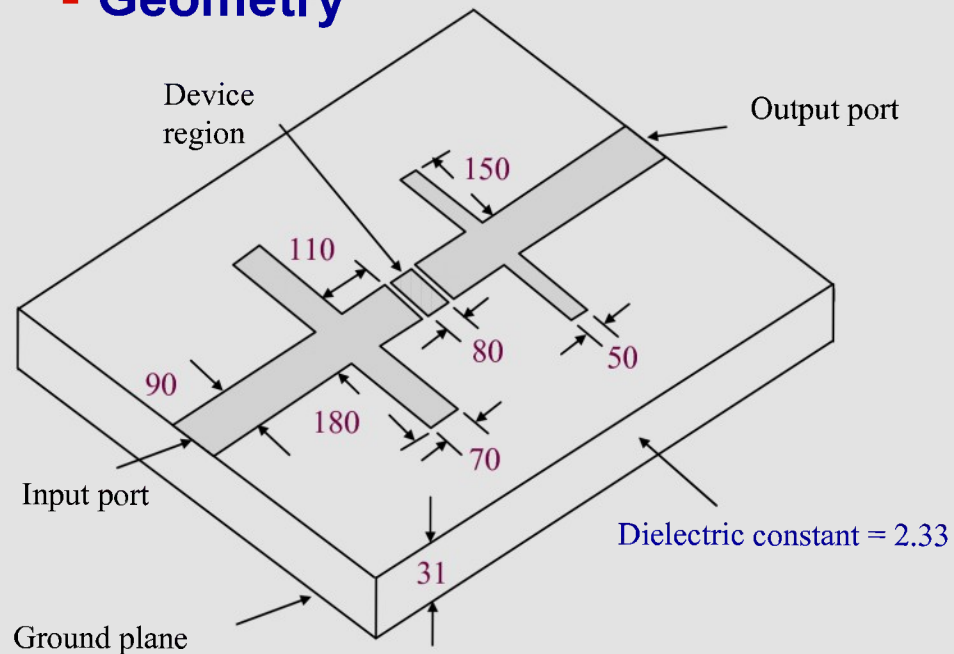


Analysis of Active Nonlinear Microwave Amplifier

■ Objective

Characterize structure
from 2-10 GHz

■ Geometry



■ Simulation Parameters

$$N_s = 1468, N_v = 7096$$

$$N_s + N_v = 8564, N_t = 512$$

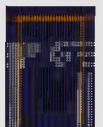
$$\Delta t = 5.0 \text{ ps}$$

■ Excitation pulse

$$\mathbf{V}^{inc}(\mathbf{r}, t) = V_0 \cos(\omega_0 t') e^{-t'^2/2\sigma^2}$$

$$\omega_0 = 2\pi \times 6 \times 10^9 \text{ rad/s}$$

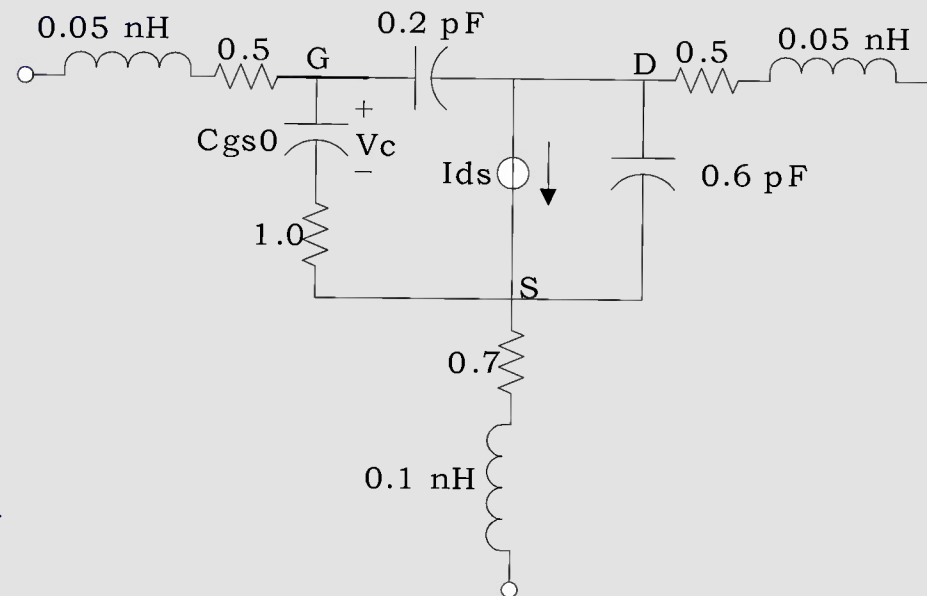
$$t' = t - 6\sigma, \quad \sigma = 6.82 \times 10^{-11} \text{ s}$$



Illinois

Amplifier : Nonlinear circuitry

■ MESFET Circuit Model

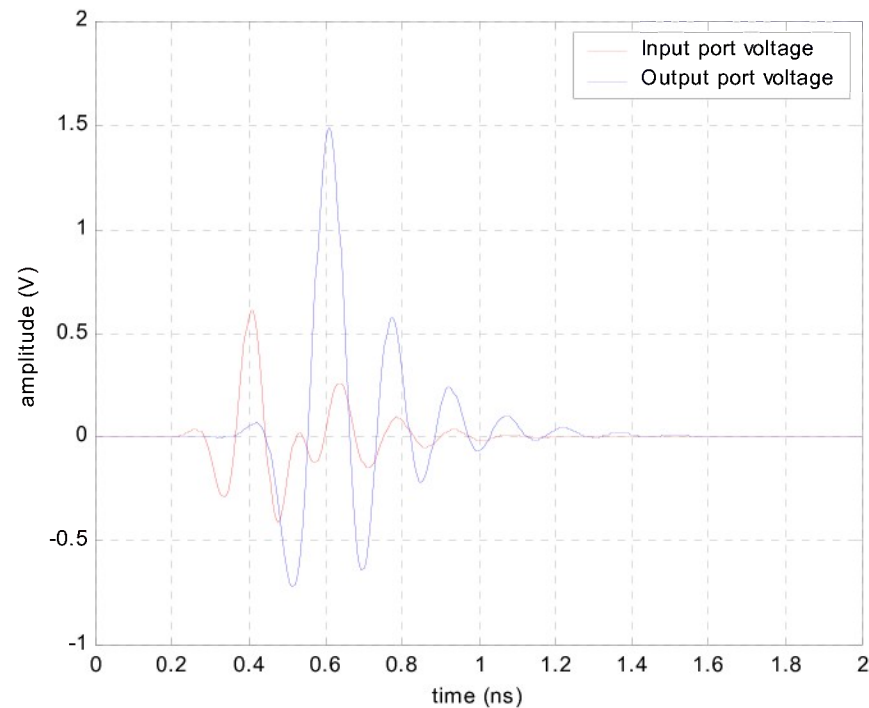


$$C_{gs}(v_c) = \frac{C_{gs0}}{\sqrt{1 - v_c / \phi_b}}$$

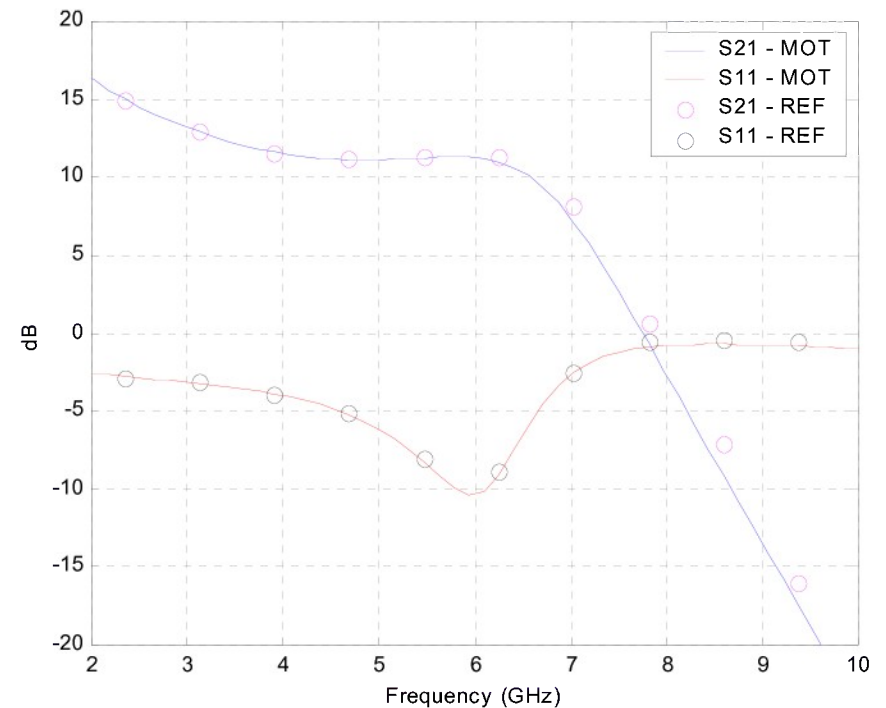
$$I_{ds}(v_{gs}, v_{ds}) = (A_0 + A_1 v_{gs} + A_2 v_{gs}^2 + A_3 v_{gs}^3) \tanh(\alpha v_{ds})$$

Amplifier: Plane Wave Interference

■ Transient input/output waveforms



■ MOT results*



* C. Kuo, B. Houshmand, and T. Itoh, "Full-wave analysis of packaged microwave circuits with active and nonlinear devices: an FDTD approach," IEEE Trans. Microwave Theory Tech., vol. 45, pp. 819-826, May 1997.

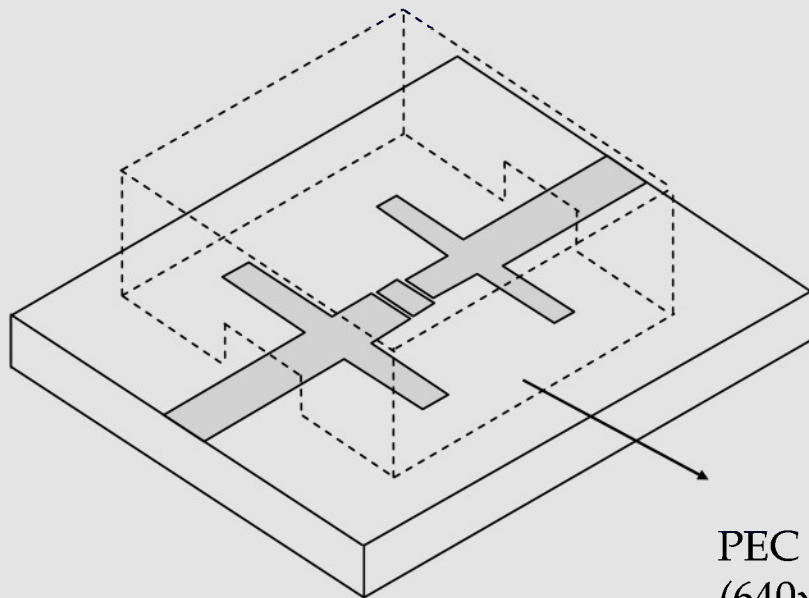


Amplifier + Shield: geometry

■ Objective

Determine effect of shielding box on S-parameters

■ Geometry



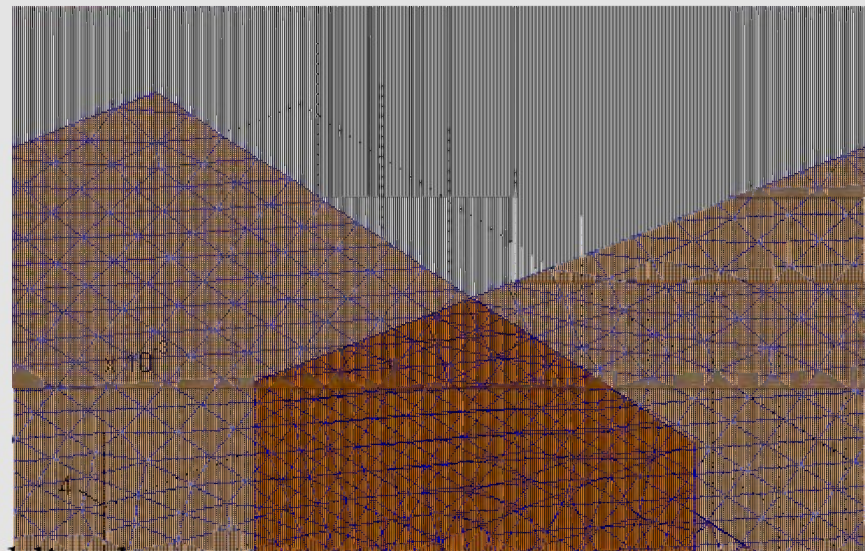
PEC shielding box
(640x186x690mils)

■ Simulation Parameters

$$N_s = 3288, N_v = 7096$$

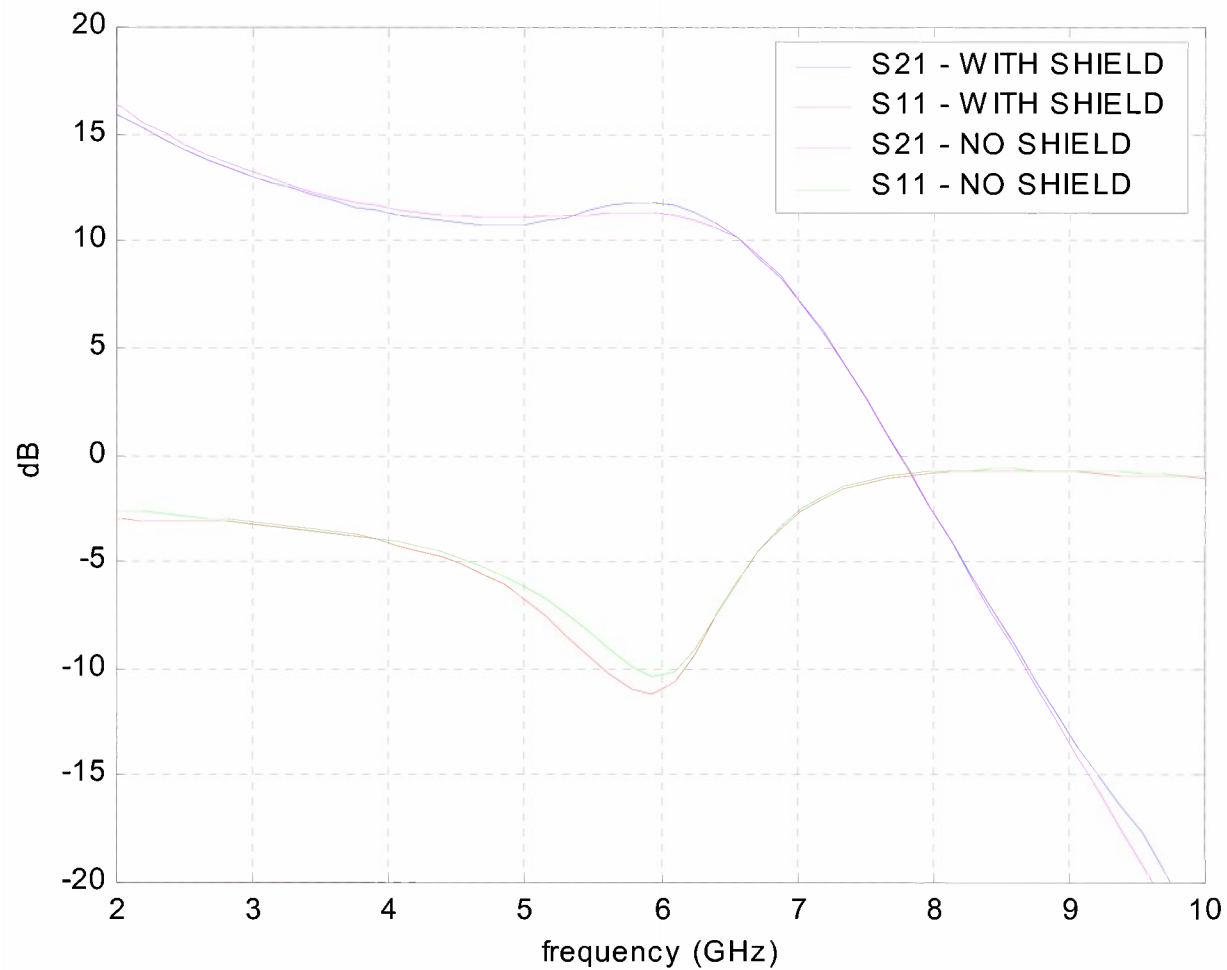
$$N_s + N_v = 10384, N_t = 700$$

$$\Delta t = 6.25 \text{ ps}$$



Illinois

Amplifier + Shield: S-parameters



Amplifier + Shield: Plane Wave Interference

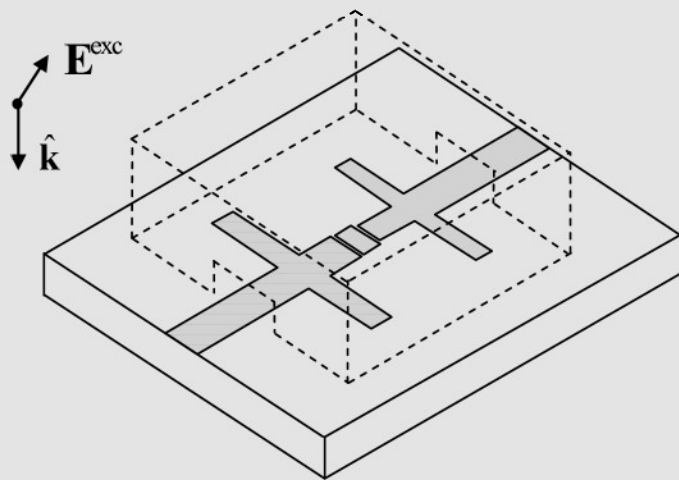
$$\mathbf{E}^{exc}(\mathbf{r}, t) = \mathbf{E}_0 \cos(\omega_0 t') e^{-t'^2/2\sigma^2}$$

$$\mathbf{E}_0 = 500\hat{\mathbf{x}} + 500\hat{\mathbf{y}} \text{ V/m}$$

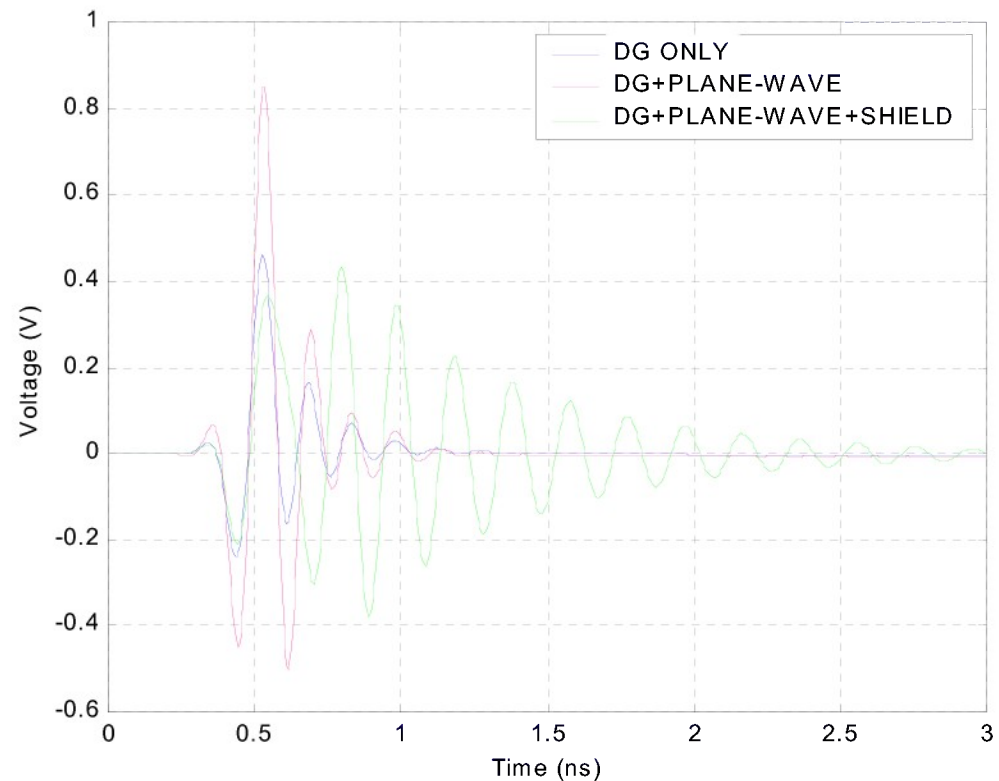
$$\omega_0 = 2\pi \times 6 \times 10^9 \text{ rad/s}$$

$$t' = t - 6\sigma + (\hat{\mathbf{z}} \cdot \mathbf{r})/c$$

$$\sigma = 8.68 \times 10^{-11} \text{ s}$$



Transient response at transistor output



Amplifier + Shield: Plane Wave Interference

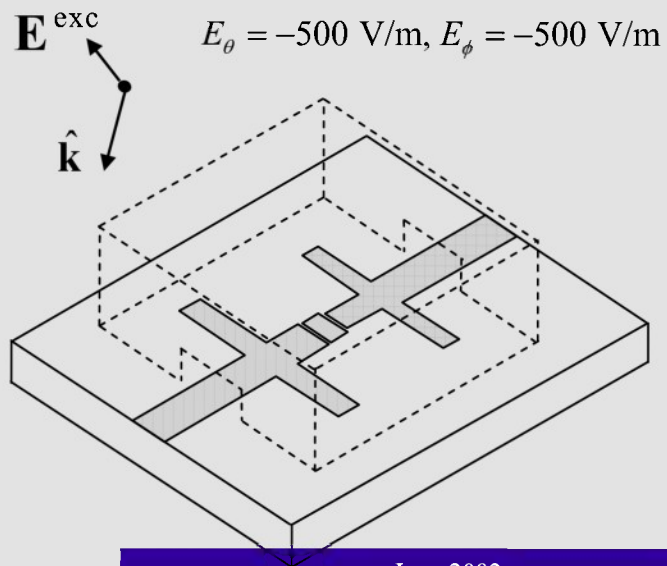
$$\mathbf{E}^{exc}(\mathbf{r}, t) = \mathbf{E}_0 \cos(\omega_0 t') e^{-t'^2/2\sigma^2}$$

$$\omega_0 = 2\pi \times 4 \times 10^9 \text{ rad/s}$$

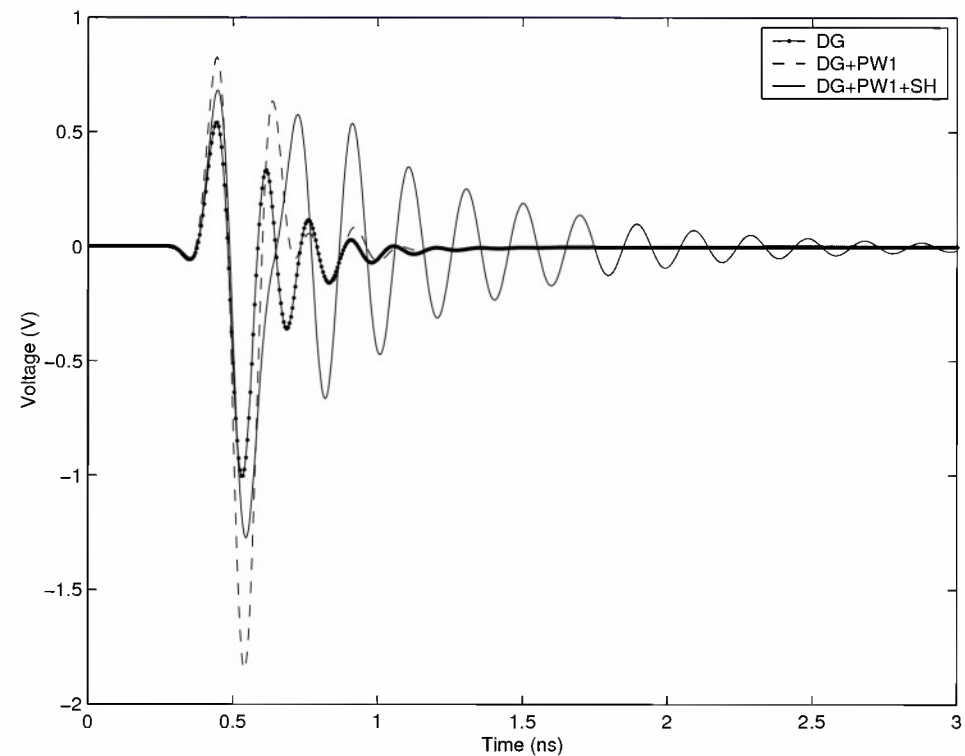
$$t' = t - 6\sigma - (\hat{\mathbf{k}} \cdot \mathbf{r})/c \quad \sigma = 1/4\pi \text{ ns}$$

$$\theta_i = 145^\circ, \phi_i = 0$$

$$\hat{\mathbf{k}} = 0.5736\hat{\mathbf{x}} - 0.8192\hat{\mathbf{y}}$$



Transient response at transistor output



Amplifier + Shield: Plane Wave Interference

$$\mathbf{E}^{exc}(\mathbf{r}, t) = \mathbf{E}_0 \cos(\omega_0 t') e^{-t'^2/2\sigma^2}$$

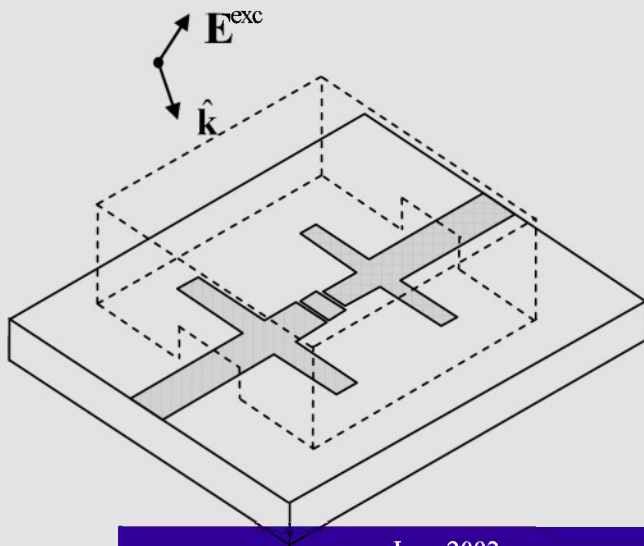
$$\omega_0 = 2\pi \times 3 \times 10^9 \text{ rad/s}$$

$$t' = t - 6\sigma - (\hat{\mathbf{k}} \cdot \mathbf{r})/c \quad \sigma = 3/14\pi \text{ ns}$$

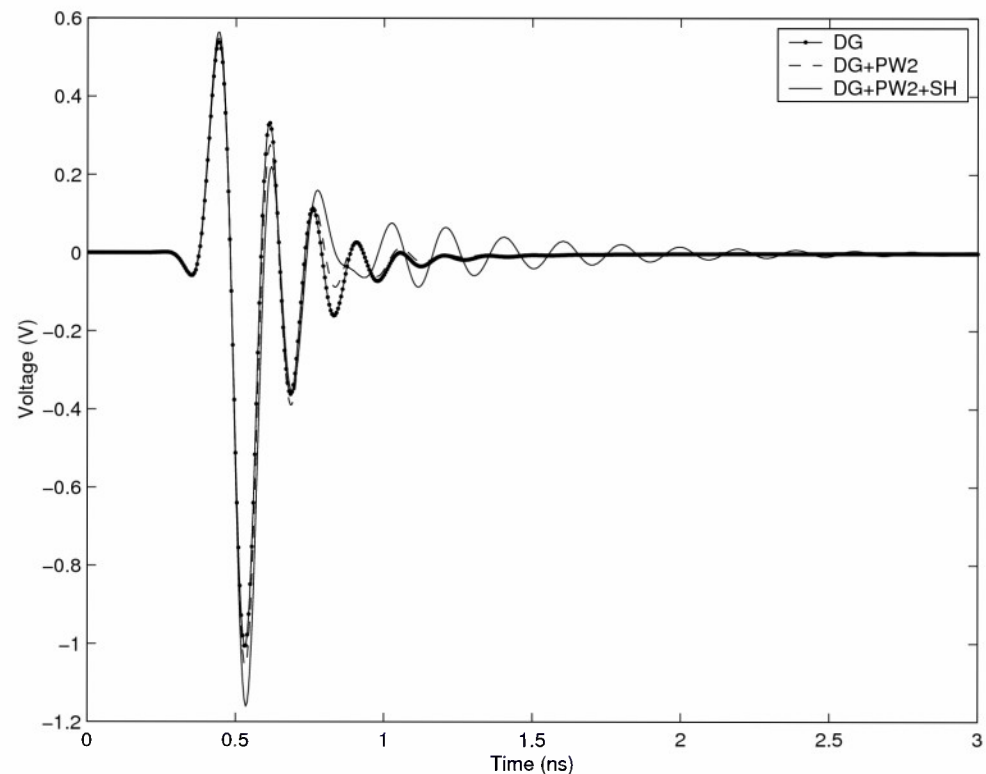
$$\theta_i = 115, \phi_i = 45$$

$$\hat{\mathbf{k}} = 0.6409(\hat{\mathbf{x}} + \hat{\mathbf{y}}) - 0.4226\hat{\mathbf{z}}$$

$$E_\theta = -500 \text{ V/m}, E_\phi = 500 \text{ V/m}$$



Transient response at transistor output



Amplifier + Shield: Plane Wave Interference

$$\mathbf{E}^{exc}(\mathbf{r}, t) = \mathbf{E}_0 \cos(\omega_0 t') e^{-t'^2/2\sigma^2}$$

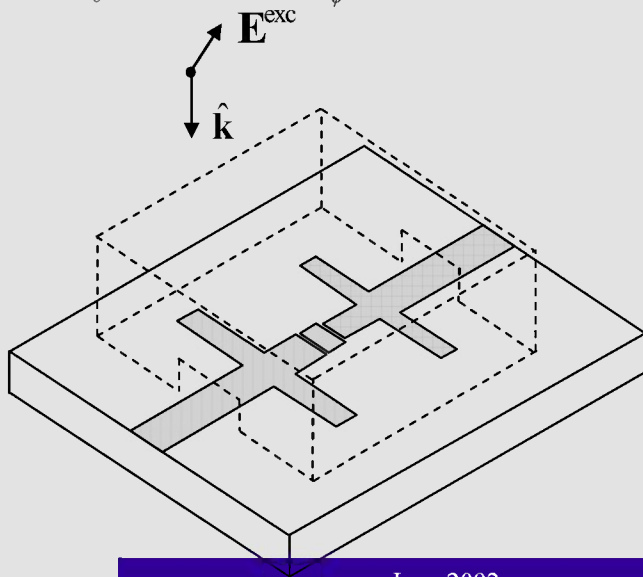
$$\omega_0 = 2\pi \times 6 \times 10^9 \text{ rad/s}$$

$$t' = t - 6\sigma - (\hat{\mathbf{k}} \cdot \mathbf{r})/c \quad \sigma = 3/11\pi \text{ ns}$$

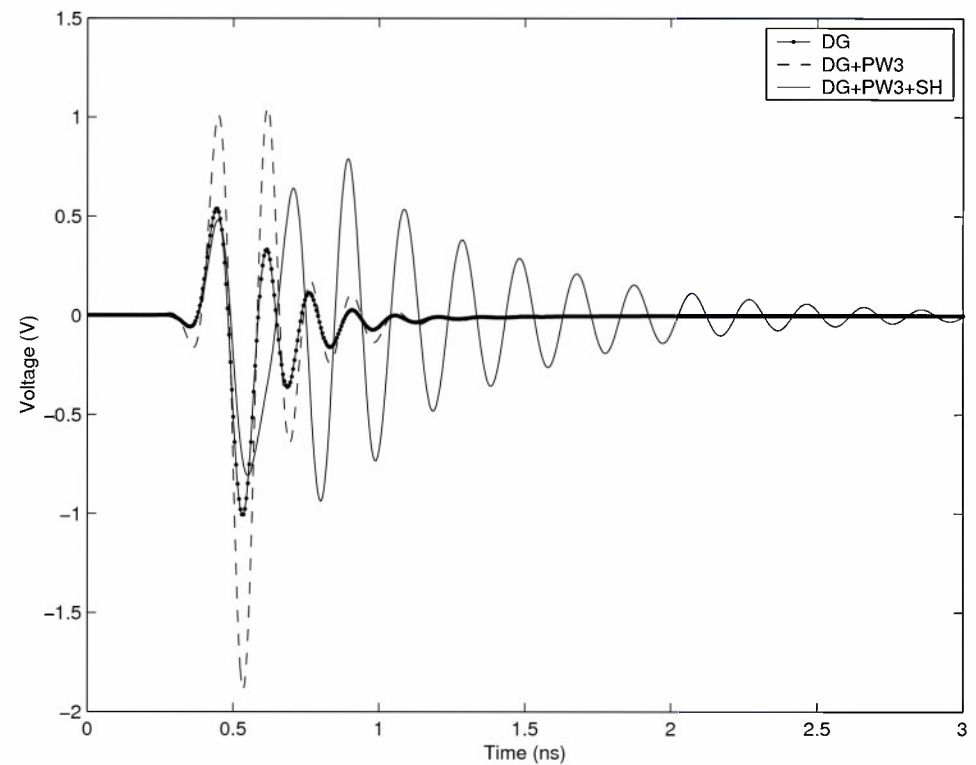
$$\theta_i = 180, \phi_i = 0$$

$$\hat{\mathbf{k}} = -\hat{\mathbf{z}}$$

$$E_\theta = -500 \text{ V/m}, E_\phi = 500 \text{ V/m}$$



Transient response at transistor output



Task 2.3: Summary

- 1) A **MOT** algorithm based on a **hybrid surface/volume** time domain integral equation has been developed for analysis of conducting/inhomogeneous dielectric bodies,
- 2) This algorithm has been accelerated with the **PWTD** technology that rigorously reduces the $O(N_T N_S^2)$ computational complexity of the MOT solver to $O(N_T N_S \log^2 N_S)$ for typical PCB structures,
- 3) Linear/Nonlinear circuits in the system are modeled by coupling **modified nodal analysis** equations of circuits to MOT equations,
- 4) A nonlinear Newton-based solver is used at each time step to **consistently** solve for circuit and electromagnetic unknowns.
- 5) The proposed method can find extensive use in EMC/EMI and signal integrity analysis of PCB, interconnect and packaging structures with realistic complexity.

